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# Investigations of several interference effects in high frequency plasmas of analytical importance

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Investigations of several interference effects in high frequency plasmas of analytical importance

by

## George Frederic Larson

A Dissertation Submitted to the Graduate Faculty in Partial Fulfillment of The Requirements for the Degree of DOCTOR OF PHILOSOPHY

> Department: Chemistry Major: Analytical Chemistry

Approved:

Signature was redacted for privacy.

In Charge of Major Work

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For the Major Desartment

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For the Graduate College

Iowa State University Ames, Iowa

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## CHAPTER I. INTRODUCTION

Since the initial studies of the analytical applications of the inductively coupled plasma (ICP) by Greenfield and associates (1) and Wendt and Fassel (2,3), the ICP has emerged as a very useful excitation source for the simultaneous multielement determination of trace elements in solution. The analytical applications of the ICP have been reviewed recently (4-9). The samples are usually examined by generating an aerosol out of the solution containing the analyte. After introduction into the high temperature plasma, the aerosol particles are rapidly decomposed into their constituent atoms. The emission spectra emitted by the released free atoms are dispersed by a spectrometer. The output of the detector is related to the total concentration in the solution of the analyte whose emission line impinges on the detector. Because absolute intensity measurements are not made, analytical calibration curves are usually established by measurements on a series of reference solutions of known composition. To obtain accurate results, the composition of the actual samples must match that of the reference solutions to the extent that neither the chemical form nor the presence of concomitants produces a significant bias in the analytical measure. The presence of varying concentrations of concomitants in the samples may cause an interference, i.e., a systematic error in the analytical

measure. Consequently, the ultimate scope of application of the ICP will depend to a great extent on its degree of freedom from the interference effects.

The types of interferences encountered in atomic emission spectrometric techniques based on the vaporization, atomization and excitation of liquid samples may be classified according to several viewpoints (10): transport, solute vaporization, vapor phase, flame or plasma geometry, and spatial distribution interferences; specific and nonspecific interferences; physical and chemical interferences; and spectral interferences. These various types of interferences are not mutually exclusive in their actions or mechanisms. The most important types of interferences are the solute vaporization, ionization (a type of vapor phase interference) and spectral interferences.

Solute vaporization interferences occur when the rate of vaporization of the desolvated aerosol particle is altered by the presence of a concomitant (ll,l2). A reduced efficiency of free atom formation can result from the formation of a less volatile compound. With this type of interference, a plot of the analyte emission intensity versus the concentration of the concomitant exhibits a linear decrease in intensity followed by a "knee" and a plateau region (ll-l4). The "knee" in the curve usually occurs at concentration ratios of the concomitant to the

analyte equivalent to the formation of a definite refractory compound. The plateau region indicates that the excess interferent is readily vaporized from the aerosol droplet. A solute vaporization interference may also result from the occlusion of the analyte in a refractory matrix of the concomitant which is not completely vaporized in the vaporization-atomization source (11-13,15-17). With this type of interference, the analyte emission intensity drops smoothly toward zero with increasing concentrations of the interferent. The types of solute vaporization interferences discussed above may occur in combination for a given pair of analyte and interferent.

An ionization interference results from a shift in the ionization equilibrium of the analyte (M):

 $M^{\circ} \stackrel{?}{\downarrow} M^{+} + e^{-}$ .

Because the electron number density is relatively low in combustion flames with only a small quantity of metallic species introduced, the presence of easily ionizable elements in the sample may produce significant increases in the electron number density (11,18-20). The resulting shift in the ionization equilibrium will produce an increase in the neutral atom number density and an accompanying (but not necessarily equal) decrease in the ion number density. Although a larger number of analytes will possess significant degrees of ionization in high temperature plasmas than in combustion flames, ionization interferences are not necessarily more pronounced. This is due to the higher electron number density in the absence of significant quantities of metallic species as well as possible deviations from local thermodynamic equilibrium (21-25). It is also relevant to acknowledge that the addition of easily ionizable elements to various electrically generated, high temperature plasmas has been found to produce significant changes in temperature (26-29) and the spatial distributions of the analyte species (30-32). Thus, the presence of varying concentrations of easily ionizable elements constitutes a significant source of interferences in many electrically generated, high temperature plasmas.

In this dissertation, the results of an investigation of the degree to which several solute vaporization and ionization interferences are observed in the ICP are presented in a quantitative manner. The results of a comparative study of several interference effects in the ICP and in a microwave-excited single electrode plasma are also presented.

When atomic emission spectrometry is employed for the determination of trace elements at concentration levels near the detection limit, the spectral background is normally a large fraction of the total measured signal. Thus, accurate

background correction is a necessity. For samples of varying composition, changes in the concentrations of concomitants often produce changes in background levels. Two specific sources of these background shifts which have received little attention, <u>i.e.</u>, stray light and the wings of broadened emission lines, are discussed. Experimental evidence is presented showing various forms of stray light originating from defects in the optical components, design and engineering of optical spectrometers. Experimental evidence is also presented illustrating that in high temperature sources the wings of certain spectral lines may contribute a significant continuum at wavelengths as far removed as 10 nm or more from the line center.

# CHAPTER II. INVESTIGATIONS OF SEVERAL INTERFERENCE EFFECTS IN THE INDUCTIVELY COUPLED PLASMA

## Introduction

The presence and degree to which certain interference effects are observed in ICP's appear to be sensitively dependent on a number of plasma properties (4-7,33-35). In view of this dependency, it is instructive to explore some of the unique properties of the annular shaped ICP (1,4,36, 37) which appear to lead not only to the high degree of freedom from interference effects but also to some of the other desirable analytical characteristics. A schematic diagram of the typical annular shaped ICP configuration, including the concentric quartz tubes, the Ar flow patterns, the load coil, and the magnetic fields (H) induced by the radiofrequency currents (I) in the load coil, is shown in Figure 1. For the initiation of the plasma, the Ar support gas is partially ionized by a tesla coil discharge. The liberated electrons and ions couple to the magnetic fields and are accelerated on each half cycle of the oscillating magnetic field. The accelerated ions and electrons flow in closed annular paths (eddy current) inside the quartz tube. The electrons (and ions) meet resistance to their flow, Joule heating results as a natural consequence, and additional ionization occurs. The steps discussed above

б







lead to an almost instantaneous formation of a plasma of extended dimensions.

Thermal isolation of the plasma is normally achieved with Reed's vortex stabilization technique (38,39), which utilizes a flow of Ar introduced tangentially along the outer quartz tube as shown in Figure 1.

After initiation of the plasma, an additional Ar flow (∿l l/min) carrying the suspended aerosol particles is introduced through the central quartz tube. In order for the plasma to serve its desired purpose, i.e., the production and excitation of free atoms, the sample particles must be efficiently injected into the plasma and remain in the high temperature environment for as long as possible. This physical situation has been difficult or impossible to achieve in many plasma configurations that have been proposed for analytical (40, 41) and other (42-47) purposes. Although the theoretical basis for the rejection of particles by high temperature plasmas has not been refined, there have been numerous observations of the deflection of particles by The primary force opposing the injection of plasmas. particles is the expansion thrust pressure or thermal repulsion (43,48,49). When gases are heated internally, they are accelerated in a direction perpendicular to the exterior surface of the plasma (50). The bombardment of the oncoming particles by the expanding gas results in a deflection of the particles.

The presence of a magnetic thrust pressure in teardrop shaped ICP's sustained by laminar, coaxial gas introduction was originally recognized by Chase (42,43) and has also been studied by Waldie (45) and Boulos (46,47). In an ICP the electric field and, consequently, the induced current density are zero at the center. The magnetic fields induced by the coil and eddy currents reinforce each other in the outer regions and oppose each other at the center. These characteristics lead to a Lorentz force which produces a magnetic compression around the sides of the plasma acting toward the central axis (42-47). The plasma is thus confined in two dimensions. The excess pressure energy can be converted into kinetic energy only by expansion outward along the central axis of the plasma in both the upstream and downstream directions. The resulting flow tends to deflect the oncoming sample particles and transport them around the plasma. However, Chase (42) found that with the vortex stabilization scheme normally used in ICP's designed for analytical applications, the low pressure region along the central axis of the plasma overwhelmed the magnetic thrust pressure.

The skin depth effect of induction heating has been used to good advantage in achieving efficient sample introduction. The skin depth effect, <u>i.e.</u>, the depth at which the eddy current is reduced to 1/e of its surface value, is

inversely proportional to the square root of the radiofrequency current frequency. This effect leads to the formation of an incipiently cooler axial channel which offers less resistance to the injection of sample particles than the high temperature annulus. The annular shape may be further developed by optimizing the flow velocity of the aerosol carrier gas.

Thus, by proper optimization of the configuration of the plasma confinement tubes, the tangential velocity component of the plasma sustaining gas, the frequency of the primary current generator, and the flow velocity of the aerosol carrier gas, an annular shaped plasma permitting efficient sample injection along the central axis is formed. It should be realized that there exists no unique configuration of the annular shaped ICP. Investigators have employed different sets of the above mentioned parameters to achieve varying degrees of annularity and sample residence times. In fact, Greenfield et al. (8) found that an annular shaped ICP may be formed with laminar or tangential introduction of the plasma support gas if the upstream "boundary" of the plasma is flattened with an additional gas flow introduced between the sample injection tube and the intermediate quartz tube. Investigations of the magnetic thrust pressure in ICP's supported by laminar gas introduction (42-47) have not considered the influence of this additional gas flow.

The annular plasma configuration leads to certain unique physical properties that make it a remarkably successful vaporization-atomization-excitation source. Once the sample particles are injected, they are heated indirectly <u>via</u> convection, conduction, and radiation absorption as they travel along the narrow axial channel inside the high temperature annulus. The relatively long residence time (on the order of 2 msec) of the sample in the high temperature region (up to  $\sqrt{7000}$  K) leads to an exceptionally high degree of atomization, hence solute vaporization interferences should be negligible. Because the free atoms and ions reside at very low concentrations in a chemically inert Ar environment, the formation of molecular species should be minimized, which results in relatively long lifetimes for the free atoms and ions.

Experimental studies of the distribution of the analyte atoms and ions indicate that the sample and its decomposition products are confined to a narrow cylindrical volume along the central axis. This confinement of the analyte atoms and ions appears to be an important factor leading to several of the desirable characteristics of the annular shaped ICP. The interaction of the sample with the sustaining eddy current is minimized by the confinement. For example, with the present ICP facility there was less than a five-watt change in the forward power in the

transmission line leading to the tuning-coupling circuit and only an approximate one watt increase in the reflected power when the solution nebulized was changed from deionized  $H_2O$ to 2.3 wt. % Na. At the observation heights normally employed for analytical purposes (15 or 20 mm above the load coil), the zone to which the sample is confined is fairly isothermal. This should minimize the effect of lateral diffusional interferences arising from differences in the vaporization rate (51) or arising from other interfering processes such as ambipolar diffusion (30-32). However, changes in the radial distribution within the axial channel (if present) will have some effect on the measured intensities because of the differences in efficiency of transfer of the emitted radiation to the detector.

The free atoms are generated in the high temperature environment of the core of the plasma which exhibits high spectral background and complex line spectra. For analytical applications the analyte free atoms or ions may be observed downstream in environments ranging downward from  $\sim 6500$  K. The optical aperture or viewing field of conventional spectrometers can be readily filled by analyte emission originating in the central channel. In this way, the analyte radiation is used most effectively.

The relatively low number densities of the analyte atoms or ions in the Ar sheath reduce self-absorption which leads

to analytical curves that are linear over 4 to 5 orders cr magnitude (52,53). This feature often permits the simultaneous determination of trace, minor and major constituents without variable dilutions of the sample solutions.

In contrast to the desirable physical properties of the annular shaped ICP, the teardrop shaped ICP (2,3,54) has a relatively poor sample introduction efficiency. The expansion thrust pressure and the magnetic thrust pressure (if laminar plasma support gas introduction is employed) act to deflect the sample particles and cause them to by-pass the high temperature region. In addition, other desirable features of the annular shaped ICP discussed above should not be present with the teardrop shaped ICP. Hence, the combination of the low frequency (4.8 MHz), laminar gas flow pattern, and the absence of an aerosol delivery tube (to produce a relatively high injection velocity) may have played a role in producing the interferences reported by Veillon and Margoshes (54).

A further distinguishing factor between various ICP's is the mode in which they are generated. For example, the plasma generator may be a self-excited oscillator, with the plasma acting as part of the resonant circuit, as used by Boumans and de Boer (55,56). Alternatively, the same type of generator may be used and coupled to the plasma <u>via</u> an impedance matching network, as utilized in some of the

earlier published work from Ames Laboratory (36,37). A third alternative (52), used in the present study, is based on crystal control of the operating frequency and the use of a tuning-coupling circuit for impedance matching purposes. In this case the plasma is a less active circuit element. A relatively high degree of freedom from interference effects has also been observed with a generator of the second type discussed above (57). However, Boumans and de Boer (33,34) have reported somewhat different interference effects produced by easily ionizable elements with their facility.

The extent to which various interelement effects occur may indeed be dependent on the plasma configuration and on the method of plasma generation, but there are other factors that play a role as well. Thus, the power dissipated in the plasma, the method of sample introduction, the height of observation, and the viewing field of the optical transfer system all have an effect.

Experimental Facilities and Procedure

## Apparatus

A photograph of the apparatus is shown in Figure 2. Detailed descriptions of the apparatus, except as modified for the present study, may be found in reference 52.



Figure 2. Plasma generation and observation facilities

- A. Radiofrequency generator;
- B. Impedance matching network;
- C. Plasma, with enclosure removed;
- D. Pneumatic nebulizer;
- E. Spectrometer

Radiofrequency generator A feedback circuit was added to this facility to maintain a constant forward power in the transmission line to the impedance matching network by controlling the screen voltage of the oscillator. The addition of this circuit was necessitated by changes in the radiofrequency power level produced by fluctuations in the mains voltage. The extent to which interference effects occurred was not affected significantly by the presence of absence of the feedback circuit. The output power waveform of this generator originally possessed a 60 Hz sinusoidal ripple resulting from the ac current in the filament of the power amplifier and 120 Hz sawtooth ripple produced by incomplete filtering of the dc voltages in the generator. A constant current supply (11 amp) eliminated the 60 Hz ripple in the radiofrequency power waveform. The 120 Hz sawtooth ripple was reduced by increasing the capacitance in the high voltage filtering network from 4  $\mu$ F to 12  $\mu$ F.

An indirect method was employed to estimate the magnitude of the ripple in terms of power since only a wattmeter (Thruline Model 43, 2500 H element, Bird Electronic Corp., Cleveland, OH) designed for constant wave power measurements was available. A calibration curve of the voltage on a stationary probe positioned inside the impedance matching unit (which picks up an unknown fraction of the radiofrequency field) versus the wattmeter reading in the derippled mode was constructed. The peak and minimum power

levels in the rippled mode at a given "average" wattmeter reading were estimated from the wattmeter readings corresponding to the peak and minimum voltages on the probe from the calibration curve. For the "average" wattmeter reading of 1025 W with the 60 Hz and 120 Hz ripple (hereafter called 1025 W with ripple), the peak power was  $\sim$ 1225 W and the minimum was  $\sim$ 750 W. In the derippled mode, the residual 120 Hz sawtooth ripple was  $\sim$ 3% peak to peak of the voltage on the probe or  $\sim$ ±25 W in the power at an "average" wattmeter reading of 1200 W.

It should be realized that the power levels mentioned in this work are those measured in the transmission line from the radiofrequency generator to the impedance matching unit. They are not equal to the power transferred to the plasma. Power losses in the load coil may amount to as much as 40% of the radiofrequency power in the transmission line (58). Additional losses may occur in the components in the impedance matching unit or from inefficient coupling to the plasma (44,59). Calorimetric measurements on a dummy load have been utilized to measure power levels with ICP facilities (8,33,44,59). These methods possess uncertainties because of differences in the conductivities of the dummy load and the plasma which lead to differences in the coupling efficiencies (8,59). Hence, the calorimetrically measured power of 700 W accepted by Boumans and de Boer (33) as a compromise for simultaneous multielement analysis with the

ICP may represent a similar power dissipation in the plasma to the 1200 W level in the transmission line employed in the present work.

<u>Aerosol generation system</u> The aerosol generation and delivery system is shown with the torch assembly in Figure 3. The pneumatic nebulizer (60) is attached to a 125 mm Teflon portion of the aerosol chamber that has an i.d. tapering from 28 mm to 18 mm. The Teflon portion is connected to an 18 mm i.d. glass tube about 125 mm long. When compared to the dual tube aerosol chamber (52), this simpler chamber reduced clean-out time between samples and decreased the magnitude of several of the interferences (Ca-PO<sub>4</sub> and Ca-Al) discussed later in this chapter.

<u>Gas flow control system</u> The gas flow control system, except as modified for the present study, has been previously described (52). An additional pressure regulator (Model 93-250 Harris Calorific Co., Cleveland, OH) was added on the Ar manifold. A flow controller (No. 8942, Brooks Instrument Div., Emerson Electric Co., Hatfield, PA) was employed on the nebulizer flow only and no filter was employed. A pressure gauge (0-100 psi) was added immediately upstream from the nebulizer to monitor the pressure drop across the nebulizer orifice. The Ar flow rates were: 12 1/min plasma and 1.0 1/min (or 1.3 1/min where indicated) aerosol carrier.



Figure 3. Schematic diagram of torch and aerosol generation system

<u>Optical system</u> The emission from the plasma was focused by a 16 cm focal length x 5 cm dia. plano-convex, fused quartz lens positioned at 30.2 cm (twice the focal length at 303.4 nm) from the slit. The center of the plasma was at 60.4 cm from the slit. Fixed 15  $\mu$  entrance and exit slits were employed. The entrance slit height was masked to 4 mm.

## Procedure

The Ca, Cr, Cd, and Mo analyte solutions were prepared by dissolving reagent grade  $CaCO_3$ , Cr metal, CdO, or  $(NH_4)_2MoO_4$  in dilute HCl. The Na concomitant solution was prepared from NaCl. Ten volume percent of concentrated HCl was added to all solutions so that any acid effects would not bias the results. In preliminary experiments with no excess HCl added to the solutions, no differences in the effects of NaCl and NaNO<sub>2</sub> were observed.

Phosphorous was added as reagent grade  $H_3PO_{l_4}$  (85%) in the Ca-PO<sub>4</sub> system. For the study of the Ca-Al system, Al(NO<sub>3</sub>)<sub>3</sub>·6H<sub>2</sub>O or AlCl<sub>3</sub> were employed.

For the study of the effects of various concomitants on <sup>Mo</sup> emission, the concomitants were added as solutions of reagent grade chlorides (K, Na) or as solutions of the metal (Al, Cu, Zn) in dilute HCl.

Intensity data were obtained by peaking the monochromator on the line and integrating the signal for 24 seconds. The signal from the blank was then subtracted to yield the net relative intensity. The concomitant blanks did not differ from the distilled water blank (within 1% of the background signal) except for the Na and Al which contained a measurable residue of Ca.

## Results and Discussion

## 

In view of the disparity of results so far reported on the  $Ca-PO_4$  and Ca-Al solute vaporization interference systems (4), it is of interest to evaluate these interferences in a facility specifically assembled for analytical purposes (52) and operated under conditions used for analytical purposes.

<u>Ca-PO<sub>4</sub> system</u> The Ca-PO<sub>4</sub> solute vaporization interference has been attributed to the formation of a refractory compound, <u>e.g.</u>, Ca<sub>2</sub>P<sub>2</sub>O<sub>7</sub> or Ca<sub>3</sub>(PO<sub>4</sub>)<sub>2</sub>, whose greater thermal stability leads to a reduced efficiency of free atom formation (11-14). In the annular shaped ICP Greenfield <u>et al</u>. (1) reported an absence of the depression effect up to  $PO_4^{3-}/Ca^{2+}$  molar ratios of 4. Wendt and Fassel (3) and Veillon and Margoshes (54) reported enhancements in freeatom absorption in teardrop shaped plasmas. Veillon and Margoshes (54) also reported an enhancement of about 100% in the calcium free-atom emission at a  $PO_4^{3-}/Ca^{2+}$  molar ratio of one and even larger enhancements in the calcium ion

emission, while Fassel (4) reported only small changes in free-atom emission in an annular shaped plasma.

The results obtained for the calcium-phosphate system at an observation height of 20 mm above the load coil with the present facility are shown in Figure 4. In this and in subsequent figures, the net emission intensities of a given species in the absence of an interferent are normalized to 100 arbitrary units at each observation height. The results of this study are in general agreement with the observations of Greenfield et al. (1) and Wendt and Fassel (3) and Fassel (4). The precipitous depression and the "knee" in the suppression curve observed in some combustion flames are not detectable, indicating the absence of the classical solute vaporization interference due to compound formation. Similar interference curves were obtained at observation heights of 15 and 25 mm above the load coil. The data presented in Figure 4 were obtained at the forward power of 1025 W with ripple. A comparison of the interference effects produced by concomitant  $PO_{ll}^{3-}$  observed at the 1025 W with ripple power level with those obtained at the derippled level of 1200 W is shown in Table I. As demonstrated by the data in Table I, the ripple in the power at the level which was originally present in the generator had no measurable influence on these interferences. The slight suppression that is observed at  $PO_{\mu}^{3-}/Ca^{2+}$  approaching 1000 is probably attributable to a transport interference resulting from changes in



Figure 4. Effect of phosphoric acid on Ca emission intensity at 20 mm above load coil (0.5 µmol/ml Ca)

		Intensity ratio <sup>a</sup>						
Height above load coil		(mm): 15		20		25		
		Ripple <sup>b</sup>	Deripple <sup>C</sup>	Ripple <sup>b</sup>	Deripple <sup>C</sup>	Ripple <sup>b</sup>	Deripple <sup>C</sup>	
Interfe	erence system Emission line							
Ca-PO,d	l							
-	Ca I 422.7 nm Ca II 393.4 nm	0.93 0.96	0.97 0.94	0.93 0.97	0.94 0.98	0.92 0.97	0.95 0.97	
Ca-Al <sup>e</sup>								
	Ca I 422.7 nm Ca II 393.4 nm	0.92 0.92	0.97 0.97	0.99 0.95	1.04 1.00	1.31 1.00	1.15 1.02	
Ca + Na	-Al <sup>f</sup>							
	Ca I 422.7 nm Ca II 393.4 nm	0.90 0.87	0.89 0.91	1.00 0.98	1.01 0.97	1.04 1.01	1.04 1.03	

Table I. Comparison of the effects of phosphate and Al on Ca emission with and without ripple in the radiofrequency power

<sup>a</sup>Intensity ratio = net intensity with interferent ÷ net intensity without interferent.

<sup>b</sup>Ripple = 1025 W with ripple power level. <sup>c</sup>Deripple = 1200 W derippled power level. <sup>d</sup>Molar Ratio  $PO_{4}/Ca = 1000$ . <sup>e</sup>Molar Ratio Al/Ca = 100. <sup>f</sup>Molar Ratio Al/Ca = 300; 200 µ mol/ml Na present. the physical properties of the solutions. It is important to note that a  $PO_{4}^{3-}/Ca^{2+}$  molar ratio of 1000 here is equivalent to approximately 5 wt. %  $H_{3}PO_{4}$ , which may be considered the analytical equivalent of determining Ca in  $H_{3}PO_{4}$ .

The suppression of Ca free-atom forma-Ca-Al system tion in the presence of increasing concentrations of Al has also been attributed to the formation of a refractory compound  $(CaAl_2O_4, Ca_3Al_2O_6, etc.)$  and to the occlusion of Ca in a refractory aluminum oxide matrix (11,12). In combustion flames, with the Al present in solution as AlCl<sub>3</sub>, several investigators have reported a "knee" followed by a plateau in the suppression curve indicating the formation of a refractory compound (15,16). With the Al present as  $Al(NO_3)_3$ , the Ca emission or absorption in flame atomizers has been observed to decrease smoothly toward zero with increasing concentrations of Al indicating the occlusion of the Ca in a refractory aluminum oxide matrix (13,15-17). In these studies with the ICP, no differences in the behavior of AlCl<sub>3</sub> and Al( $NO_3$ )<sub>3</sub> were observed.

The Ca-Al interaction has been studied by Greenfield <u>et al</u>. (1) and by Fassel (4) in annular shaped plasmas, and also by Wendt and Fassel (3) and Veillon and Margoshes (54) in teardrop shaped plasmas. These investigators reported significantly different results. Greenfield <u>et al</u>. (1)

initially reported no change in calcium atom emission up to Al/Ca molar ratios of 50. Wendt and Fassel (3), and Veillon and Margoshes (54) observed enhancements in calcium freeatom absorption in their plasmas. Later, Fassel (4) observed a slight enhancement of both the calcium atom and ion emission and Veillon and Margoshes (54) reported an approximate five-fold enhancement of the calcium atom emission when the Al/Ca molar ratio was increased from zero to 8.

The results of the present study are shown in Figure 5. These data were obtained at the forward power of 1025 W with ripple. The absence of any depression at low molar ratios indicates that no measurable solute vaporization interference due to compound formation occurs. At Al/Ca molar ratios approaching 100 (1350 µg/ml AI) slight suppressions are observed in the calcium atomic and ionic line emission at 15 mm above the load coil. This suppression may at first glance be attributed to the occlusion of the Ca in a refractory aluminum oxide matrix formed during the aerosol droplet evaporation process, because the suppression of the Ca II emission decreased with increasing observation height until at 25 mm above the load coil it is virtually absent. However, the observation that  $AlCl_3$  and  $Al(NO_3)_3$  solutions produced essentially identical results in the ICP does not support this hypothesis.



Figure 5. Effect of Al on Ca emission intensity at three heights of observation above load coil (0.5 µmol/ml Ca)

The interpretation of the experimental results on the Ca-Al interactions is rendered difficult by the possibility that ionization suppression of Ca and other interactions occasioned by the presence of increasing concentrations of Al in the plasma may obscure solute vaporization interference. Thus, the enhancement of Ca I emission at 25 mm above the load coil may be rationalized as a manifestation of a shift of the Ca ionization equilibrium

 $Ca^{\circ} \stackrel{2}{\leftarrow} Ca^{+} + e^{-}$ 

toward the free atom, because ionization of the increasing Al concentrations in the plasma might increase the number density of electrons. The absence of a significant simultaneous depression of the Ca II emission can also be rationalized since the degree of ionization of Ca has been found to be exceptionally high [>99% (24,25)] in the absence of Al.

To buffer whatever interactions are occurring through the presence of relatively high concentrations of easily ionizable elements, Na was added at a concentration of  $4600 \ \mu\text{g/ml}$  (as NaNO<sub>3</sub>) to another set of otherwise identical solutions. The results obtained for these solutions are shown in Figure 6. The addition of this quantity of Na virtually eliminated the interference effects produced by up to 1350  $\mu$ g/ml Al (molar ratio Na/Al = 4). Although higher Al concentrations produced depressions of both the Ca I and



MOLAR RATIO (AI/Ca)

Figure 6. Effect of Al on Ca emission intensity in the presence of Na at three heights of observation above load coil (0.5 µmol/ml Ca; 4600 µg/ml Na)

Ca II emission at 15 mm, these depressions were essentially absent at the 20 mm observation height.

The comparison of the interferences produced by concomitant Al with and without excess Na at forward powers of 1025 W with ripple and 1200 W derippled shown in Table I indicate that the ripple in the power had no major influence on the interferences. The enhancement of the Ca I line at 25 mm at 1025 W with ripple level is measurably larger than that observed at the 1200 W derippled level. The same trend was observed with concomitant Na discussed below. However, unequivocal interpretations of the role of solute vaporization and the interactions occasioned by increasing concentrations of Al in the nebulized solution and in the plasma await a better understanding of the nebulization and transport processes and of the physical environment prevailing in the plasma.

### Interference effects produced by easily ionizable elements

Reports in the literature on the existence and degree to which interference effects may occur in the ICP from changing concentrations of easily ionizable elements have been rather limited, considering the possible severity of such effects and the great degree to which they have been observed in other electrically generated plasmas (27-32,61-64).

Hoare and Mostyn (65) reported that 1000  $\mu$ g/ml Na did not affect the emission intensity of B and that 10,000  $\mu$ g/ml

Li produced only slight enhancements of atomic lines and slight depressions of ionic lines for an annular shaped inductively coupled plasma. Kirkbright and associates (66, 67) briefly reported that 50-fold weight excesses of K or Na did not affect the emission intensities from 100  $\mu$ g/ml S, 100 µg/ml P, 100 µg/ml I, 10 µg/ml As, 10 µg/ml Se, and 10  $\mu$ g/ml Hg in their annular shaped ICP. Since the initial disclosure (68) of a portion of the results presented below, several other studies on the interferences produced by easily ionizable elements have been published. The recent studies of Abdallah et al. (35) are in general agreement with the present work. Agreement with the recent results of Boumans and de Boer (33,34) exists to the extent that under the operating conditions chosen by the authors as "compromise" conditions for simultaneous multielement analysis, the ICP possesses a high degree of freedom from interelement interactions produced by concomitant easily ionizable elements.

The results of the present study on the effect of 300  $\mu$ mol/ml Na (6900  $\mu$ g/ml) on the emission intensities of atomic and ionic lines of three selected elements of different ionization energies (Ca, Cr, and Cd) are presented in Figure 7. The ionization potentials of Ca, Cr, and Cd are 6.11, 6.76, and 8.99 eV (69), respectively (with no correction applied for temperature effects on the partition functions). These data were obtained with an aerosol carrier
Figure 7. Variation of effect of Na on analyte emission intensity with an aerosol carrier gas flow rate of 1.0 l/min

> Net intensities of a given species in the absence of Na are normalized to 100 arbitrary units at each height and power. (Analyte concentration: 0.5 µmol/ml; Na concentration: 6900 µg/ml)

> > 900 W
> >  O 1200 W
> >  X 1025 W with ripple



gas flow rate of 1.0 1/min and at forward power levels of 1025 W with ripple and the derippled levels of 900 and 1200 W. The magnitudes and trends of these interferences did not differ significantly with the forward power level or waveform as shown by the data in Figure 7. Hence, a small to moderate ripple in the forward power waveform with an aerosol carrier gas flow of 1.0 1/min may be tolerated without significant influence on the interference effects produced by concomitant In this context it is important to note that enhance-Na. ments in the time integrated intensities of the Ba I 553.6, Ba II 455.4, Cu I 324.8, Zn I 213.9, and Zn II 206.2 nm lines were observed with the addition of Na by Kniseley et al. (70) in an ICP facility (system III of reference 53) which possessed an ~50% peak-to-valley 120 Hz ripple on the radiofrequency voltage envelope. A series of oscilloscope tracings of the time resolved emission indicated that the ripple in the power waveform played an important role in producing the enhancements observed with this facility. However, the addition of Na to the nebulized solution had no significant influence on the time resolved emission waveforms for the spectral lines shown in Figure 7 with the ICP facility employed in the present study when an aerosol carrier gas flow of 1.0 l/min was utilized. To resolve this discrepancy additional information on the instantaneous power dissipated in the plasma is required.

The effects of increasing Na concentrations from  $69 \ \mu g/ml$  to  $6900 \ \mu g/ml$  on the emission intensities of Ca, Cr, and Zn with a forward power of 1025 W with ripple are presented in Figures 8-10. Before attempting some rationalizations of the trends of the data plotted in Figures 8 to 10, it is appropriate to recall that the additions of relatively high concentrations of Na to the nebulized solution affected the forward and reflected power levels to a very small extent, i.e., without the stabilizing feedback circuit there was less than a five-watt change in forward power in the transmission line and only an approximate one watt increase in the reflected power when the solution nebulized into the plasma was changed from deionized water to a solution containing 2.3 wt. % Na. Under the conditions employed in this study, effective iron excitation temperatures were observed to change only  $\sim3$  K/watt (71). Thus changes in power absorbed by the plasma do not appear to be responsible for the effects observed. As noted above, the electrons released by the ionization of the increasing concentrations of an easily ionizable element such as Na may increase the number density of electrons to a sufficient degree to suppress the ionization of the analyte species. The trends of the curves plotted in Figures 8 to 10 tend to indicate the presence of a small degree of ionization suppression, i.e., for the more easily ionized Ca and Cr



Na CONCENTRATION

Figure 8. Effect of Na on Ca emission intensity at three heights of observation above load coil (0.5 µmol/ml Ca)



Figure 9. Effect of Na on Cr emission intensity at three heights of observation above load coil (0.5 µmol/ml Cr)



Figure 10. Effect of Na on Cd emission intensity at three heights of observation above load coil (0.5 µmol/ml Cd)

species, there is indeed an enhancement in neutral atom line intensities with increasing concentrations of Na, especially at an observation height of 25 mm. If the analyte ionization suppression by the addition of large concentrations of Na were a dominant process, then for an analyte which is highly ionized (Ca) the large enhancements observed in the atomic lines should be accompanied by much smaller depressions in the ionic lines. For a species such as Cd, which is ionized to a lesser degree [ $\sqrt{85\%}$  (24,25)], smaller enhancements in the atomic line and larger depressions in the ionic lines would be observed with the suppression of ionization. The existence of some ionization suppression is suggested by the observation that the ionic lines are suppressed to a greater extent than the atomic lines in Figures 8-10 and that the enhancements of both Ca I and Cr I emission are observed high in the plasma (25 mm above the load coil).

Hence, ionization suppression resulting from increases in the electron number density  $(n_e)$  plays only a minor role in the interferences shown in Figures 7 to 10. The absence of significant increases in the  $n_e$  which may be inferred from the data in Figures 7 to 10 was also found by Kalnicky (24) who determined spatially resolved  $n_e$ 's with and without 6900 µg/ml Na in the nebulized solution (25). Abdallah <u>et al</u>. (35) and Mermet and Robin (72) have also observed no significant increases in the  $n_e$  with the addition of Na.

These observations are in conflict with the n\_'s calculated from the theoretical plasma model of Barnett et al. (73) and of Mermet and Robin (72). In the theoretical plasma model of Barnett et al. (73), the sample (Mg) was found to be the predominant source of electrons at the temperatures [ $\stackrel{2}{\sim}7000$ K (24,25)] which prevail in the analytically useful observation zone. According to this model, the addition of Mg (or elements with lower ionization potentials) above a certain Mg/Ar ratio leads to an increase in the electron number density. However, uncertainties in the Mg/Ar ratios due primarily to the lack of knowledge of the quantity of Ar which mixes with the sample preclude a comparison of the model and real plasmas. Mermet (22,23), Kalnicky (24), and Kalnicky et al. (25) have suggested that ionization equilibrium does not exist in the ICP. Thus, the absence of ionization equilibrium, which is assumed to exist in the theoretical models, may also contribute to the discrepancies in the model and real plasmas.

Greater effects would be observed on the Cd II 226.5 nm and Cr II 284.3 nm lines than on the Ca II 393.4 nm line if changes in the effective excitation temperatures were the dominant interfering process. This is due to the high excitation potentials of the Cd II [5.47 eV (69)] and Cr II [5.88 eV (69)] lines, the low excitation potential of the Ca II line [3.15 eV (69)], and the high degree of ionization

of Ca [>99% (24,25)]. The similar behavior of these lines in Figures 8-10 suggests that changes in effective excitation temperatures do not appear to be a dominating factor. This suggestion has been confirmed by Kalnicky (24), who found that the addition of 6900  $\mu$ g/ml Na to the nebulized solution had only a minor effect on the spatially resolved excitation temperatures under similar operating conditions (25).

It should be emphasized that the reported relative intensities in Figures 7-10 represent the effective values within the viewing field of the transfer optics. The importance of this factor is illustrated by the effective horizontal emission profiles at 20 mm above the load coil plotted in Figure 11. The profiles were obtained with the optical transfer system described in reference 71 and no Abel inversion has been applied. It is seen that the Ca I emission is greatly enhanced by the addition of Na at a distance of approximately 4 mm from the central axis of the plasma, while the Ca II emission is only very slightly enhanced by Na in this region. The Cd I emission is also slightly enhanced off axis by the addition of Na while the Cd II emission is not significantly affected in this region.

It is quite certain that other factors play a role in the trends of the interference effects plotted in Figures 8 to 10. For example, the concentration of Na employed may have been great enough to produce a transport interference

Figure 11. Effect of Na on analyte horizontal emission distribution

(Analyte concentration: 0.5 µmol/ml; height of observation: 20 mm above load coil; forward power: 1025 W with ripple)

> -**О-** no Na --**Д**-- 6900 µg/ml Na



caused by changes in the physical properties of the nebulized solutions.

The influence of increasing the aerosol carrier gas flow rate to 1.3 l/min on the interferences produced by 6900 µg/ml Na at the forward power of 1025 W with ripple and derippled levels of 900 and 1200 W is shown in Figure 12. In contrast to the observations discussed above, relatively large interferences and significant variations of these with power level and waveform are present with an aerosol carrier gas flow rate of 1.3 1/min. The enhancements of all lines (from ∿15 to 280%) at the 15 mm observation height may be rationalized in part by an increase in the effective excitation temperature. Indeed, Kalnicky (24) measured an increase in the excitation temperature from  $\sim$ 4150 to 4400 K in the center of the plasma with the addition of 6900  $\mu$ g/ml Na to the nebulized solution at the 15 mm observation height with an aerosol carrier gas flow rate of 1.3 1/min at 1000 W forward power (25). This change in excitation temperature would result in an increase in the Cd J 228.8 nm line intensity of 136% at the center of the plasma (ignoring shifts in the ionization equilibrium). The existence of ionization suppression is suggested by the large decreases in the Cd II 226.5 nm line at the 25 mm observation height. Other interfering processes are important as suggested by the large enhancements of both the Ca atom and ion lines (which are

Figure 12. Variation of effect of Na on analyte emission intensity with an aerosol carrier gas flow rate of 1.3 l/min

> Net intensities of a given species in the absence of Na are normalized to 100 arbitrary units at each height and power. (Analyte concentration: 0.5 µmol/ml; Na concentration: 6900 µg/ml)



relatively insensitive to excitation temperature) at 900 W. These enhancements are greater than those observed for lines which are significantly more sensitive to temperature changes, e.g., the Cd I 228.8, Cd II 226.5, and Cr II 284.3 nm lines.

Boumans and de Boer (33) have reported relatively large interferences produced by concomitant easily ionizable elements with aerosol carrier gas flow rates of 1.5 l/min or greater especially at lower power levels but not with the 1.3 1/min flow rate. This discrepancy may be the result of any one or the combination of the differences in the experimental facilities and operating conditions. For example, if the initial aerosol carrier gas velocity is an important factor in producing the larger interferences at the higher flow rate, the larger aerosol delivery tube orifice diameter of 1.80±0.02 mm employed by Boumans and de Boer in their most recent studies (34) (compared to the 1.5 mm orifice used in the present study) may indeed be a factor contributing to the discrepancies. However, in the absence of a more detailed knowledge of the origins of these interferences and of the influence of various experimental parameters on the physical environment prevailing in the ICP, any attempt to reconcile the disparity in the observed interference effects must rely on speculation.

The injection velocity of the aerosol carrier gas is determined not only by the gas flow rate and diameter of the

orifice of the aerosol delivery tube but also by the configuration of the delivery tube. In this context it is relevant to distinguish between the aerosol delivery tube which terminates in a 1.5 mm diameter jet-like orifice (74) used in the present work (fabricated by collapsing a 4 mm i.d. quartz tube onto a Pt wire of 1.5 mm diameter) and the tube which terminates in a section of straight-walled capillary tubing. Greenfield et al. (1,75) have utilized an aerosol delivery tube terminating in a 2.0 mm i.d. capillary tube which they describe as the "correctly shaped injector" (75). Scott and Kokot (76) advocate the use of a capillary tube with a smaller i.d. of 1.4 mm. The results of some preliminary studies of the interferences produced by 6900 µg/ml Na with an aerosol delivery tube terminating in a 50 mm section of 1.5 mm i.d. quartz tubing (hereafter called "capillary aerosol tube") are presented in Table II along with data obtained with the "standard" aerosol tube. The reproducibilities of the intensity ratios with the standard aerosol tube are generally within acceptable levels, i.e., The most notable features of the intensity ratios for ∿5%. the capillary aerosol tube are the substantially higher variations for the Ca I 422.7 and Ca II 393.4 nm lines and to a lesser extent for the Cr I 425.4 nm line. For example, the intensity ratios observed for the Ca II 393.4 nm line at the 15 mm observation height varied between 0.68 and 1.15

		Intensity ratio <sup>a</sup>				
Species	Height of observation (mm)	Standard aerosol tube	Capillary aerosol tube			
Ca I 422.7	nm 15 20 25	0.91 ± 0.03 <sup>b</sup> (4) <sup>c</sup> 1.02 ± 0.04(4) 1.61 ± 0.19(4)	0.77 ± 0.21(9) 0.83 ± 0.13(9) 1.18 ± 0.18(9)			
CaII 393.4	nm 15 20 25	0.87 ± 0.03(3) 0.87 ± 0.02(3) 0.88 ± 0.02(3)	0.93 ± 0.18(10) 0.79 ± 0.12(10) 0.76 ± 0.09(10)			
Cr I 425.4	nm 15 20 25	0.90 ± 0.05(4) 0.94 ± 0.02(4) 1.23 ± 0.05(4)	0.87 ± 0.11(4) 0.87 ± 0.05(4) 1.05 ± 0.06(4)			
CrII 284.3	nm 15 20 25	0.87 ± 0.03(4) 0.83 ± 0.03(4) 0.85 ± 0.02(4)	1.14 ± 0.02(3) 0.87 ± 0.02(3) 0.81 ± 0.01(3)			
Cd I 228.8	nm 15 20 25	1.01 ± 0.01(5) 0.90 ± 0.004(5) 0.91 ± 0.02(5)	1.49 ± 0.05(3) 1.00 ± 0.04(3) 0.92 ± 0.02(3)			
CdII 226.5	nm 15 20 25	0.94 ± 0.02(4) 0.87 ± 0.03(4) 0.82 ± 0.02(4)	1.16 ± 0.06(3) 0.91 ± 0.02(3) 0.79 ± 0.01(3)			

Table II. Influence of aerosol tube configuration on interference effect due to Na

<sup>a</sup>Intensity ratio = net intensity with 6900  $\mu$ g/ml Na ÷ net intensity without Na.

<sup>b</sup>Standard deviation of observed intensity ratios.

<sup>C</sup>Values in parentheses are the number of determinations.

with an average of 0.93±0.18 over the course of these experiments in contrast to the range of 0.84 to 0.89 with an average of 0.87±0.03 with the standard aerosol tube. These data were obtained over a period of more than a year and represent variations in torch placement within the load coil, in nebulizer performance, and in numerous other experimental parameters. The relatively large variations in the intensity ratios shown in Table II suggest that adequate control of an unidentified experimental parameter(s) was not maintained over the course of these experiments. Regardless of the origins of these variations, this situation should be resolved if the capillary aerosol tube is to be utilized for analytical purposes. Systematic investigations of these two aerosol tube configurations are needed to determine their relative merits, i.e., detection limits, interference effects, deposition of sample material in the orifice, and memory effects.

A definitive interpretation of the magnitudes and trends of the analyte line behavior discussed in this chapter requires a far more detailed knowledge of the spatial distributions of the temperatures and the analyte free atoms and ions, of the influence of possible deviations from local thermodynamic equilibrium (22-25), the ionization processes occurring, on the role played by the Ar sustaining gas, and of the influences of the sample nebulization and transport

processes. The present inability to interpret these results in a more definitive manner should not detract from the fact that at the height of observation ( $\sim$ 15 to 20 mm) and flow rate (1.0 l/min) selected for excellent powers of detection for a majority of elements (77) these interferences are small or insignificant for reasonable changes in the concentrations of easily ionizable elements. In fact, these interferences are far smaller than those generally observed in combustion flames (18-20) and other plasmas (26-32).

#### Effect of matrix change on analyte emission

The experimental results summarized above suggest the interesting and potentially very valuable possibility of establishing single analytical curves for the determination of an analyte in a variety of matrices. Documentary evidence that this excitation source, operated under the conditions described in this paper, offers this promise is shown in Table III. These data show that a complete change in the matrix in solution induced a maximum change in signal of only -6% (Na matrix). In contrast, in a high temperature  $N_2O-C_2H_2$  flame the matrix effects ranged from -70 to +50% (51).

							N <sub>2</sub> O-C <sub>2</sub> H <sub>2</sub>
Height above load coil (mm):	l	5	2	0	25	ō	flame (51)
Concomitant (2500 µg/ml)	Mo I <sup>a</sup>	Mc II <sup>b</sup>	Mo I	Mo II	Mo I	Mo II	Mo I
None	100	100	100	100	100	100	100
K	102	99	102	97	117	96	30
Na	107	95	105	94	119	94	30
Al	102 <sup>c</sup>	97 <sup>°</sup>	103 <sup>°</sup>	95 <sup>°</sup>	119 <sup>c</sup>	97 <sup>°</sup>	150
Cu	100	1.00	100	100	102	98	150
Zn	100	1.00	101	100	104	98	120

Table III. Effect of concomitants on emission of 25  $\mu g/ml~\text{Mo}$ 

<sup>a</sup>Mo I 390.3 nm.

<sup>b</sup>Mo II 281.6 nm.

<sup>C</sup>Data corrected for emission by concomitant.

#### Suggestions for Future Research

A newly developed ultrasonic nebulizer-desolvation system has produced improvements in detection limits by an order of magnitude or more (78) over the pneumatic nebulizer employed in this dissertation research. Because of the greater mass transport rate of the ultrasonic nebulizerdesolvation system and the important influences of the entire sample introduction apparatus on interference effects, the interference systems studied in this dissertation research should be investigated with the ultrasonic nebulizerdesolvation system. These investigations may be more confirmatory than exploratory in nature, since Boumans and de Boer (33,34) and Abdallah et al. (35) have observed a high degree of freedom from interference effects with their ultrasonic nebulizer-desolvation systems coupled to ICP's. However, because of the often subtle or unexpected dependence of interference effects on various experimental parameters, these studies are necessary before the ultrasonic nebulizer-desolvation system is adopted. Additional interference systems should also be investigated, particularly those which may occur in the desolvation apparatus (34,35,79,80).

### CHAPTER III. COMPARISON OF INTERFERENCE EFFECTS IN A MICROWAVE SINGLE ELECTRODE PLASMA AND IN A RADIOFREQUENCY INDUCTIVELY COUPLED PLASMA

#### Introduction

In the preceding chapter it was shown that the ICP possesses a high degree of freedom from several interference effects. In addition to the ICP, the single electrode plasma (SEP) has recently emerged as a promising atomization and excitation source for the optical emission determination of trace elements in solution. The SEP is sustained by capacitive coupling of the plasma to the high frequency field concentrated at the tip of a single electrode. A radiofrequency (43 MHz) version of such a plasma was first employed for the determination of elements in solution by Bădărău et al. (81), and a microwave-excited version, in which the plasma was formed on the central conductor of a co-axial waveguide, was first employed by Mavrodineanu and Hughes (82) for the same purpose. The analytical applications of these plasmas have been recently reviewed by Fassel (4), Greenfield et al. (83), Boumans (9), and Skogerboe and Coleman (84). Although such terms as "capacitively coupled plasma", "electronic torch", "high frequency brush discharge", and "ultra high frequency plasma torch" have been

employed to describe these plasmas, the term "single electrode plasma" or SEP will be used here in accordance with reference 10.

Although the promise of these plasmas as atomization and excitation sources for optical emission spectroscopy resides primarily in their excellent powers of detection (4-6,9,78, 83,84), their freedom from interelement interferences or matrix effects will be an important factor in determining their eventual scope of application for the determination of trace metals in samples of widely varying composition. Thus, it is of interest to make direct comparisons of the relative magnitudes of interference effects in plasmas operated under experimental conditions either recommended or commonly used for the analysis of samples, even though these effects may be dependent on such experimental parameters as the exciting frequency, the nature of the support gas, the method of coupling the high frequency power supply to the plasma, the characteristics of the power generator, the power dissipated in the plasma, the torch configuration and gas flow rates, the viewing field of the optical transfer system, and the method of sample transport and injection.

Presented in this chapter are the results of a comparative study of the interelement effects observed in both the SEP and the ICP (similar to those which are commercially available) produced by: (a) an easily ionizable element (Na) on the emission intensities of neutral atom and ion lines of Ca, Cr, Mo, and Zn; (b) concomitants of different ionization potential on Mo neutral atom and ion line emission; and (c) the well-known phosphate on calcium and aluminum on calcium solute vaporization interferences. The results of this study are in basic agreement with those of another comparative study (79) in which greater freedom from interference effects was found in an ICP than in a SEP sustained in  $N_2$  (rather than Ar as employed in the present study).

Experimental Facilities and Procedure

#### SEP facility

The Hitachi UHF Torch Generator employed was similar to the version described in references 61 and 85. The magnetron (H3032L, 2.45 GHz) was operated at an anode current of 260 mA at 2 KV. The Ar sheath or coolant gas flow between two quartz tubes concentric with the electrode was 5.6 l/min. The aerosol carrier gas flow rate between the electrode and the inner quartz tube was set at 2.6 l/min; the interferences discussed in this chapter were not strongly dependent on the aerosol carrier gas flow rate between 2 and 3 l/min. The nebulizer (60), dual tube aerosol chamber (52), and desolvation facility (74) have been previously described. The aerosol transport rate into the plasma was equivalent to  $\sim 0.06$  ml/min with a solution uptake rate of 1.7 ml/min. These conditions correspond to those recommended by the manufacturer.

The spectrometric instrumentation has been previously described (86), except that the following modifications were made: (a) 20 µm entrance and exit slits masked to a height of 3 mm were employed; (b) the external optics consisted of a 15 cm x 5 cm diameter plano-convex fused quartz lens positioned at 28.3 cm (twice the focal length at 303.4 nm) from the slit and 28.3 cm from the plasma; and (c) a Keithley Model 417 picoammeter and a Texas Instruments Model FWD recorder were employed.

#### ICP facility

The ICP facility has been described in the preceding chapter. The forward power was 1025 W with ripple and the reflected power was approximately 10 W. The aerosol carrier gas flow rate was 1.0 l/min. No external desolvation apparatus was employed.

#### Procedure

The preparation of solutions and data collection procedures have been described in the preceding chapter, except that relative intensity measurements for the SEP were obtained from strip chart recordings.

#### Results and Discussion

#### Interference effects produced by easily ionizable elements

There have been numerous reports of rather severe interference effects caused by changing concentrations of easily ionizable elements in various versions of the SEP. Bădărău (81) reported depressions of Pb I 405.7 nm emission with increasing concentrations of alkali and alkaline earth elements in a radiofrequency-excited (43 MHz) SEP sustained in air. Tappe and van Calker (62,87) observed severe interferences on Mn I 403.0 nm emission with increasing concentrations of the alkali elements in a radiofrequency-excited (27 MHz) SEP sustained in air. Jantsch (88) has described interferences produced by increasing concentrations of Na on Fe I 371.99 nm and Al I 396.2 nm emission intensity in a microwave-excited (2.45 GHz) SEP supported by  $\mathrm{N}_{2}^{}.$  At the observation height where maximum intensity for Fe I 371.99 nm was observed (18 mm above electrode tip), the addition of 1840 µg/ml Na produced enhancements of ∿20% in the Fe I intensity and  $\sim300\%$  in the Al I intensity. In contrast to the observations of Jantsch, Kessler (89) reported that in a similar SEP several easily ionizable elements (Na, K, Cs, Ca, Sr, and Ba) had little influence on the Fe I 371.99 nm line but produced enhancements of the Al I 396.2 nm line. In a more extensive study with a very similar SEP sustained by  $N_2$ , Sermin (90) found that the interference effects produced by

Na were quite dependent on the analyte. For example, Ni neutral atom emission was only slightly affected (<10% change) by up to 100  $\mu$ g/ml Na but increasing concentrations of Na produced a steady depression ( $\sim$ 50% with 1000 µg/ml Na). Similar effects were observed with neutral atom lines of Fe and Mo. Neutral atom lines of Cr were enhanced with increasing concentrations of Na up to 1000  $\mu$ g/ml ( $\sim$ 100%), whereas a decrease in intensity was observed with a further increase to 10,000 µg/ml Na. Similar effects were observed with neutral atom lines of Al and Mn. Steady decreases in intensity with increasing Na concentration were also observed for neutral atom lines of B and Co. Kitagawa and Takeuchi (28) have described interferences produced by Na in a Hitachi SEP (2.45 GHz) supported by  $N_2$  or Ar. For the  $N_2$  supported plasma, the interferences appeared to be less severe than for the Ar supported plasma but were much worse than those observed with the ICP employed in the present study. Murayama (27,85) and Murayama et al. (61) have also described interferences produced by easily ionizable elements in microwave-excited SEP's supported by Ar.

The use of a spectrochemical buffer (an additive such as an alkali or alkaline earth element added to both the sample and reference solutions for the purpose of making the measure of the analyte less sensitive to variations in interferent concentration) with the SEP has been recommended by

Murayama (27), Kessler (89), and Boumans <u>et al.</u> (79). Indeed, Govindaraju <u>et al</u>. (91) have utilized an approximate ten-fold excess of Sr as a spectrochemical buffer in the analysis of silicate rocks with a microwave-excited SEP sustained in N<sub>2</sub>. However, since the interference curves (analyte intensity <u>vs</u>. interferent concentration) from various SEP's have not exhibited plateau regions (27,28,88, 90), it is reasonable to presume that the buffer must be present in a large excess to overcome variations in the interferent concentrations in the samples.

Reports in the literature on the interference effects produced by easily ionizable elements in the ICP were discussed in the preceding chapter.

The results of the present comparative study on the effects of Na on the emission intensities of neutral atom and ion lines of Ca, Cr, Mo, and Zn for two heights of observation in the SEP and in the ICP at the height normally employed for analytical applications for this facility are presented in Figures 13-16. In these and in subsequent figures, the net emission intensities of a given species in the absence of the interferent are normalized to unity at each observation height for each plasma. Because the relative intensity data are plotted on a logarithmic scale, the excursions of the curves from the unity value give a direct comparison of the interferent effects. The ion lines of Mo

## Figure 13. Comparison of effect of Na on Ca emission in SEP and ICP

(Concentration of Ca: 0.5 µmol/ml; height of observation: SEP 3 or 7 mm above electrode, ICP 20 mm above load coil)

O Ca I 422.7 nm

X Ca II 393.4 nm

RELATIVE INTENSITY



# Figure 14. Comparison of effect of Na on Cr emission in SEP and ICP

(Concentration of Cr: 0.5 µmol/ml; height of observation: SEP 3 or 7 mm above electrode, ICP 20 mm above load coil)

O Cr I 425.4 nm

X Cr II 284.3 nm



Na CONCENTRATION

# Figure 15. Comparison o: effect of Na on Mo emission in SEP and ICP

(Concentration of Mo: 25 µgm/ml; height of observation: SEP 3 or 7 mm above electrode, ICP 20 mm above load coil)

Mo I 390.3 nm X Mo II 281.6 nm



# Figure 16. Comparison of effect of Na on Zn emission in SEP and ICP

(Concentration of Zn: 0.5 µmol/ml; height of observation: SEP 3 or 7 mm above electrode, ICP 20 mm above load coil)

O Zn I 213.9 nm

X Zn II 202.6 nm


RELATIVE INTENSITY

and Cr in the SEP are not included because of their low signal to noise ratio.

The trends reported here for the SEP are in general agreement with those previously described by Murayama (27,85), Murayama et al. (61), and by Kitagawa and Takeuchi (28) for microwave SEP's sustained in Ar. The most striking features of Figures 13-16 are the large relative changes in analyte emission intensities observed with the SEP for changes in Na concentration whereas only minor changes are observed in the ICP over the entire range of Na concentrations studied. The large enhancements observed in the SEP for Na concentrations of only 23 µg/ml (corresponding to 1 µmol/ml) suggest that considerable difficulty would be encountered if samples contain even minor but variable concentrations of an easily ionizable element. Equally significant is the observation that at higher concentrations of concomitant Na large relative changes in analyte emission intensity are observed even for relatively small changes in Na concentration. The absence of a plateau region in the interference curves for the SEP suggests that additions of an excess of an easily ionizable element to the sample and reference solutions to buffer the interactions to a constant level would only be marginally successful. Moreover, when solutions containing 2300 µg/ml Na or greater were nebulized into the SEP, a Na deposit formed on the electrode tip and caused the plasma to

become unstable. When solutions containing 6900  $\mu$ g/ml Na are nebulized into the SEP, the plasma tended to degenerate into a ribbon-like discharge maintained between the center conductor or electrode and the surrounding quartz tube. Concentrations of Na as high as 23,000  $\mu$ g/ml do not affect the stability of the present ICP in any apparent way although deposits may form on the aerosol injection orifice.

It is worth noting that the changes in the emission signals for the Ca II 393.4 nm, Cr II 284.3 nm, Mo II 281.6 nm, and Zn I 213.9 nm (lines for which best detection limits are observed in the ICP) are only -6, -7, -5, and -8 percent, respectively, for the analytical equivalents of determining these elements in deionized water and in a 0.23 wt. % of Na. Thus, synthetic reference solutions prepared by the incremental additions of these analytes to distilled water would provide reasonably accurate analysis for their determination in sodium salts.

## Effect of concomitants on Mo emission

The effects of various concomitants with differing ionization potentials on Mo emission in the SEP and the ICP are presented in Table IV. All of the concomitants produced significant interference on the Mo I emission in the SEP. In the ICP, small interferences were observed with the more easily ionizable concomitants (K, Na, Al) whereas the concomitants with higher ionization potentials (Cu, Zn) produced

<u>, , , , , , , , , , , , , , , , , , , </u>		Re SEP <sup>a</sup>	lative intensit: ICP <sup>1</sup>	ies D
Concomitant <sup>C</sup> (Ionization Potential, eV)		Mo I <sup>d</sup>	Mo I <sup>d</sup>	Mo II <sup>e</sup>
None		100	100	100
К	(4.34)	47	102	97
Na	(5.14)	68	105	94
Al	(5.98)	154	103	95
Cu	(7.72)	309	100	100
Zn	(9.39)	150	101	100

Table IV. Effect of concomitants on emission of 25  $\mu\text{g/ml}$  Mo in SEP and ICP

<sup>a</sup>Observation height: 5 mm above electrode tip. <sup>b</sup>Observation height: 20 mm above load coil. <sup>c</sup>Concomitant concentration: 2500 µg/ml. <sup>d</sup>Mo I 390.3 nm. <sup>e</sup>Mo II 281.6 nm.

essentially no interference. These results suggest the interesting and very valuable possibility of establishing single analytical curves for the determination of an analyte in a variety of matrices in the ICP.

## $Ca-PO_4$ interference system

A literature review on the origins of this interference and its occurrence in the ICP was presented in the preceding chapter of this dissertation. The author is not aware of any reports on the existence of interference on Ca emission by the presence of  $PO_{\mu}^{3-}$  in microwave-excited SEP's whereas West and Hume reported an absence of interference in a radiofrequency-excited SEP in  $N_2$  (92). The results of the present study are shown in Figure 17 for two heights of observation in the SEP and for the normal observation height in the ICP. The precipitous depression and the "knee" in the interference curves for Ca I emission with the SEP is reminiscent of the solute vaporization interference as observed in some combustion flames. However, the enhancements of Ca II emission at low  $PO_{\parallel}/Ca$  molar ratios and the depression at high molar ratios are not consistent with this interpretation. Changes in analyte distribution produced by changes in the rate of vaporization of the aerosol particles in the presence of  $PO_{\mu}^{3-}$  (93) may be partially responsible for the interactions reported in Figure 17. In marked contrast to the SEP, the interference on Ca I and Ca II by concomitant  $PO_{\mu}^{3-}$  is essentially negligible in the ICP.

# Figure 17. Comparison of effect of ${\rm H}_3{\rm PO}_4$ on Ca emission in SEP and ICP

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(Concentration of Ca: 0.5 µmol/ml; height of observation: SEP 3 or 7 mm above electrode, ICP 20 mm above load coil)

O Ca I 422.7 nm
X Ca II 393.4 nm



## Ca-Al interference system

A literature review on the origins of this interference and its occurrence in the ICP was presented in the preceding chapter of this dissertation. The author is unaware of reports of any investigations of the Ca-Al system in a microwave-excited SEP in Ar. In microwave-excited SEP's in  $N_2$ , enhancements at Al/Ca molar ratios greater than  $\sqrt{20}$ have been reported by Govindaraju <u>et al</u>. (91), whereas depressions ( $\sqrt{30\%}$ ) have been observed with additions of Al with Na present as a spectrochemical buffer (90). West and Hume (92) reported an absence of interference in their radiofrequency-excited SEP in  $N_2$ .

The results of the present study are shown in Figure 18. The interference on Ca I and Ca II emission by concomitant Al in the SEP is probably a combination of the solute vaporization interference and other interactions occasioned by the addition of the easily ionizable element Al to the plasma. Concomitant Al has little effect on Ca I or Ca II emission in the ICP as shown in Figure 18. Identical results were obtained with the Al added as  $AlCl_3$  or  $Al(NO_3)_3$ . The small interference that is observed in the ICP may be virtually eliminated by the addition of Na to all solutions as was shown in the preceding chapter.

# Figure 18. Comparison of effect of Al on Ca emission in SEP and ICP

(Concentration of Ca: 0.5 µmol/ml; height of observation: SEP 3 or 7 mm above electrode, ICP 20 mm above load coil)

O Ca I 422.7 nm
X Ca II 393.4 nm



RELATIVE INTENSITY

## Conclusion

Definitive interpretations of the interference effects observed in various versions of the SEP are rendered exceedingly difficult by the nonuniform distributions of the composition, "temperature", and electron number density in these plasmas. To provide a physically meaningful basis for an interpretation, spatially-resolved, radial distributions of these physical parameters must be employed rather than the experimentally measured, spatially averaged distributions (27,28). In an SEP-type discharge, especially those supported by noble gases, the electronic or excitation temperature may far exceed the gas temperature (26,82,85, 94-96). The apparent absence of local thermodynamic equilibrium adds further complications and may also be a significant factor in producing the relatively high degree of interference effects which have been reported for SEP-type discharges.

In the present version of the SEP, the sample particles are transported to the plasma region by a gas flowing between the electrode and a concentric quartz tube. Thus, the sample particles must overcome the expansion thrust pressure (43, 48,49) to be injected efficiently into the plasma. The advantages of efficient sample introduction were apparently realized by Pforr (97), who introduced the sample aerosol through the center of the electrode tip. However, in order

to maintain a stable, symmetrical plasma, the maximum carrier gas flow was found to be only  $\sim 0.07$  l/min. Further work on this approach may result in reduction of some of the interelement effects observed in SEP-type plasmas.

That the microwave-excited SEP in Ar does not produce efficient atomization of thermally stable compounds is suggested by the suppression of Ca I emission by the addition of  $PO_h^{3-}$  or Al to the nebulized solution, as shown in Figures 17 or 18, although the behavior of the Ca II line indicates that other processes are important. In this context it is interesting to note that West and Hume (92) reported an absence of an interference effect on Ca emission with the addition of more than 100-fold excesses of aluminum and phosphate in a radiofrequency-excited SEP in  $N_2$ . This absence may have been due to the higher gas temperature prevailing in the N<sub>2</sub> supported discharge. The exciting frequency as well as other experimental parameters apparently play an important role as evidenced by the depression of Ca emission (in the presence of excess Na) with the addition of Al reported by Sermin (90) in a microwave-excited SEP in  $N_{2}$ . Indirect evidence that the microwave-excited SEP in Ar does not produce efficient atomization of thermally stable compounds can be found in an early comparison of detection limits in the SEP and the ICP (4). The detection limits reported for elements which form stable monoxides

 $[D_{0}(MO) > 7 \text{ eV}]$  are generally one to two orders of magnitude greater for the SEP than the ICP although the detection limits for most other elements with these plasmas are similar.

# CHAPTER IV. THE STRAY LIGHT/BACKGROUND SHIFT PROBLEM IN ULTRATRACE ANALYSES BY OPTICAL EMISSION SPECTROMETRY

## Introduction

When atomic emission spectroscopy is employed for the determination of trace elements at concentrations near the detection limit, the spectral background will normally be a large fraction of the total measured signal. Thus, accurate analyses require precise background corrections. In samples of varying composition, charges in the concentration of concomitants may produce subtle changes in the background level. These background shifts may be caused by true spectral line or band interferences, by indirect effects on the spectral background underlying the analysis line, or by stray light contributions. These shifts will lead to an analytical bias unless appropriate corrections are applied. If this bias results from stray light contributions, it may masquerade as an interelement interference or matrix effect when, in reality, limitations in the spectrometer components or defects in engineering design or construction are the primary causes. Although there have been excellent discussions on various stray light effects in absorption (98-101), fluorescence (102-105), and Raman (106,107) spectroscopy, the nature and magnitude of these effects have received little attention when trace element determinations are

performed by atomic emission spectroscopy. In this chapter examples of various forms of stray light originating from grating and optical design defects in spectrometers are illustrated and the biases these effects may produce on the final analytical result are assessed if proper corrections are not made.

#### Stray light

Stray light is broadly defined as the unwanted radiation that reaches the detector in unintended ways (108). Stray light originating from grating imperfections may occur as Rowland (109-111), worm (112-114), or Lyman (110,111,115) ghosts produced by periodic errors in the grating groove spacing, as satellites, "grass", or "near scatter"  $(\Lambda\lambda\tilde{<}2.5-5.0 \text{ nm})$  (110,111) produced by regular or irregular grating defects, or as "far scatter"  $(\Lambda\lambda\tilde{>}5 \text{ nm})$  produced by local or microscopic groove or blank imperfections as well as by roughness in the faces or edges of the grooves (110,111).

Progressive improvements in grating production and replication in recent years have significantly reduced stray light originating from grating imperfections. For instance, the intensities of first order Rowland ghosts have been reduced from as great as 2% of the parent line for gratings ruled under mechanical control to <0.001% for gratings ruled under interferometric control (110,111). Although some of the early gratings ruled under interferometric control

exhibited high levels of far scatter due to jitter in the ruling diamond as the servo-control system sought the nullposition, refinements in the control systems have resulted in significant reduction in far scatter (111). Holographically recorded gratings, which are recordings of an interference phenomenon, do not exhibit line ghosts and, through the use of virtually grainless photopolymers, also exhibit low levels of scattered light (111).

In principle, there is a theoretical lower limit that can be achieved in the relative levels of near and far scatter. Even a "perfect" diffraction grating with  $N_r$ rulings, where  $N_p$  represents an even number, will form  $N_p-2$ secondary interference maxima between the principal or ordinal maxima of adjacent orders (116-118). Near each principal maximum, this interference pattern is approximated by the diffraction pattern produced by an aperture of width equal to the grating width projected through the angle between the normal of the grating and the diffracted ray (110,116-118). Hence, this interference pattern has been described as the diffraction pattern of the (effective) grating aperture (110,117). A reduction of the relative intensity of the "feet" of this diffraction pattern may be achieved by apodization of the grating aperture with an appropriate mask. For instance, a diamond shaped mask will decrease the relative intensities of the "feet" of the

1.1

grating aperture diffraction pattern when narrow slits are employed (110,119,120). Fortunately, the theoretical lower limits for far scatter resulting from the secondary maxima are much lower than the far scatter usually observed in high quality spectrometers. Thus, the stray light arising from grating imperfections discussed above and from the other sources discussed below presents a far more serious problem.

Instrumental line broadening effects and stray light may originate from various sources other than grating imperfections. Finite widths of slits, imperfections in the slit jaws, aberrations of the optical system, diffraction by mirror apertures, and optical misalignment may broaden concomitant spectral line images to a sufficient degree to cause spectral interferences. In addition, the primary radiation entering the spectrometer, as well as zero and other order diffracted rays, may be scattered from dust particles and from imperfections in optical surfaces or may be reflected or scattered from interior surfaces of the spectrometer to produce general stray light.

Multiple diffractions (reentry spectra) have also been identified as a significant source of stray light in some in-plane Littrow (106,121), Ebert (122,123), and Czerny-Turner (124-126) spectrometers. For certain component arrangements in Ebert or Czerny-Turner mountings, oncediffracted radiation is returned to the grating by the reflecting optics. This once-diffracted light will undergo

a second diffraction, ultimately striking the camera mirror and reaching the detector. The problem of multiple diffractions, once identified, may be eliminated by masking a portion of the grating (which reduces the throughput) or, in some cases, by employing a grating with a different groove spacing (124-126).

Finally, the detectors in polychromators are not normally positioned in individual light tight channels immediately behind the exit slits. Thus, stray light may result from leakages and reflections along the optical path as well as from reflections and scattering in the secondary optics. The majority of the data obtained with the direct reading polychromators presented in this chapter was obtained by R. K. Winge of the Ames Laboratory-ERDA and is presented here to provide a complete discussion of the various sources of stray light.

#### Line broadening

In high temperature sources, such as the ICP, the emitted lines may be broadened to the extent that the wings produce a significant contribution to the spectral background as far removed as 10 nm or more. The identification of the broadening mechanisms [presumably the strongly perturbing close collisions (127,128)] which give rise to the significant intensity in the extreme wings of spectral lines is beyond the scope of the present discussion. The spectral interferences which arise from the wings of very strong emission lines have not been generally recognized in optical emission spectroscopy, in part due to the high stray light rejection factors which are required for their identification. These high rejection factors may be readily achieved with double monochromators (129). However, this type of spectral interference may be quite important in ultratrace analysis when excitation sources with low background emission are employed.

It is also important to realize that spectral interferences from continuum radiation may also be produced by processes other than line broadening. Such sources as recombination reactions, molecular continua, and blackbody radiation from incompletely vaporized particles (130-132) may give rise to significant spectral continua. In addition, concomitants may also induce indirect effects on the spectral background, <u>e.g.</u>, through changes in temperature and electron number density (26,130).

## Experimental Facilities

#### Spectrometers

The spectrometers employed in this study are described in Table V.

Table V. Spectrometric instrumentation

Spectrometer I-A:	0.5 m Ebert mount (Model No. 82000, Jarrell-Ash Division, Fisher Scien- tific Co., Waltham, MA) Grating, (1180 grooves/mm) blazed for 250 nm in first order, was replicated from a master (No. 1227, Jarrell-Ash) which was ruled under interferometric control. This master was retired some years ago because of its high stray light characteristics. Fixed 15 µm entrance and exit slits were employed and masked to a height of 4 mm. The detector and readout electronics have been described previously (52).
Spectrometer I-B:	Same instrument as I-A except for

- spectrometer 1-B: Same Instrument as 1-A except for grating. Grating (1180 grooves/mm) was replicated from a more recent master (No. 1370, Jarrell-Ash), which was ruled under interferometer control and blazed for 240 nm.
- Spectrometer I-C: Same instrument as I-A except for grating. Grating (1200 grooves/mm) was holographically recorded with optimized efficiency for 200-700 nm. (J-Y Optical Systems, Metuchen, NJ).

Spectrometer II-A: Applied Research Laboratories QVAC 127 polychromator. The optical path consists of a field lens, an entrance slit, a grating, and 47 exit slits, after which 45° mirrors deflect the appropriate wavelengths to photomultipliers located above and below the focal plane. The grating, replicated from Bausch & Lomb master #845, has 2160 grooves/mm and is blazed for the 170-215 nm region. Wavelength scans over small intervals are achieved by moving the entrance slit along the Rowland circle. Table V. (Continued)

Spectrometer	II-B:	Same instrument as II-A except for grating. Grating was holographically recorded as a replacement for grating in II-A (J-Y Optical Systems, Metuchen, NJ).
Spectrometer	III:	0.5 m Czerny-Turner double mono- chromator (Model 285, GCA/McPherson, Acton, MA). The grating, replicated on both sides of blank, has 1200 grooves/mm and is blazed for 300 nm in first order. The entrance, intermediate, and exit slits were set at 10 $\mu$ m and masked to a height of 2 mm. Stray light rejection ratios of <10 <sup>-10</sup> at 0.5 nm and <10 <sup>-11</sup> at 1.0 nm from Ar laser line at 514.5 nm are specified by the manufacturer. The detector and readout electronics have been described previously (52).

#### Excitation sources

Inductively coupled plasmas (ICP) were used as the excitation sources. The ICP facility employed with spectrometers I-A, -B, and -C was described in Chapter II. The forward power reading was 1200 W and the reflected power reading was  $\tilde{5}$  W. The Ar flow rates were 1.0 l/min for the aerosol carrier and 12.5 l/min for the plasma gas. The 4 mm high observation zone was centered 15 mm above the load coil.

The ICP generator (Model MN-2500E, Plasma-Therm, Inc., Kresson, NJ) employed with spectrometers II-A and -B and III was operated at a forward power level of 1100 W at a crystal controlled frequency of 27.12 MHz. The Ar flow rates were 1.0 1/min for the aerosol carrier and 15 1/min for the plasma gas. The observation zones were centered 15 mm above the load coil, and their heights were 6+ mm for spectrometer II and 2 mm for spectrometer III.

## Results and Discussion

#### Near scatter, satellites, and Rowland ghosts

The problems encountered in ultratrace analyses that may be caused by these sources of stray light are illustrated for the case of Al in the presence of Ca. Two of the most useful lines of Al occur at 394.40 and 396.15 nm, in close proximity to the sensitive ion lines of Ca at 393.37 and 396.85 nm.

Calcium is highly ionized  $[\tilde{>}99\% (24,25)]$  in the ICP and the two ion lines are emitted in unusually high intensity, even at relatively low concentrations of Ca. As shown by the recordings in Figure 19, these lines are detectable as impurities when the solutions containing 5 µg/ml of Al are introduced into the plasma. When solutions containing appreciable concentrations of Ca are nebulized, e.g., the 100 to 500 µg/ml contents indicated in Figure 19, the Al lines reside in a deep canyon between the Ca II 393.37 and 396.85 nm lines. Significant upward shifts in the background underlying both Al lines accompany these increases in Ca concentration. Although the background shifts are considerably less in spectrometer I-C than in I-A, the shift ( $\Delta B$ ) caused by 500 µg/ml Ca in spectrometer I-C was still equivalent to 2 µg/ml Al. The grating in spectrometer I-B produced a similar shift. Thus, a significant portion of the background shift for spectrometer I-C (and I-B) may be due to a combination of the diffraction effects of the grating aperture (the peak intensity of the secondary maximum at a position corresponding to 396.156 nm would be  $\sqrt{9} \times 10^{-6}$  of the peak intensity of the principal maximum at 396.847 nm when infinitely narrow slits are employed with a grating with 60,000 grooves), diffraction by the mirror apertures, scattering from the mirror, aberration and slit broadening, and misalignment of the optical components rather than grating

Figure 19. Effect of stray light on the observed background signal between the Ca II 393.4 and 396.8 nm lines



imperfections. Astigmatism and slit broadening effects played a minor role because a reduction in slit widths from 15 to 5  $\mu$ m and slit heights from 4 to 2 mm produced only a slight reduction in background shift relative to the Al I lines.

The stray light adjacent to the Al I 396.15 nm line for spectrometer I-C was found to be  $\sqrt{7} \times 10^{-5}$  of the peak intensity of the Ca II 396.85 nm line, which is approximately the same fraction as observed at a  $\sqrt{0.6}$  nm displacement from the Ne 632.8 nm line of a He-Ne laser (Model S-203-H, C. W. Radiation Inc., Mountain View, CA 94040) when an auxiliary lens was employed to fill the full aperture of the grating. These data indicate that the background shifts between the Ca II lines shown in Figure 19 were produced primarily by stray light and instrumental broadening effects with some possible contribution from plasma line broadening effects discussed below.

Two minor aspects of the recording in Figure 19 are worthy of mention. First, the background shifts ( $\Delta$ B) observed with these spectrometers were not proportional to the Ca concentrations. Self-absorption of the Ca II lines may contribute to this nonlinearity (see discussion in a later portion of thesis), because a concentration of 500 µg/ml Ca is more than 6 orders of magnitude greater than the detection limit for Ca. Second, the broad band "grass", marked "A" in the

I-A recordings, arose from reflections and scattering of the Ca II 393.37 nm line in the exit slit assembly. This "grass" was eliminated (see spectrometer I-C recording) by blackening the entire assembly.

The recordings in Figure 20 show an example of stray light contributions from near scatter and other sources and from Rowland ghosts. The presence of 50 or 100  $\mu$ g/ml Ca in the nebulized solution contributes both a shift in the underlying background and two interfering "lines". There are no known lines or bands attributable to Ca at these wavelengths. The "lines" are, in fact, the 7th and 8th order Rowland ghosts of the Ca II 396.85 nm line. Although the grating used in spectrometer II has an unusually high ghost intensity and is not generally acceptable for ultratrace analytical applications, the shoulders of the Rowland ghosts contribute less background to the Al I 396.15 nm line than the general upward shift in the underlying background contributed by near scatter and instrumental and plasma line broadening effects (see discussion below).

#### Line broadening

The scan between the Ca II ion doublet for the 1000  $\mu$ g/ml Ca solution obtained with the double monochromator, spectrometer III, also exhibits a significant background shift as shown in Figure 21. The shift at the Al I 396.15 nm line, which is equivalent to  $\sim 0.4 \mu$ g/ml Al for the solution



# ~0.1 nm

Figure 20. Effect of Rowland ghosts and stray light on the background signal observed with spectrometer II-A in the region of the Al I 396.1 nm line





Figure 21. Background shift produced by broadening of the Ca II 393.4 and 396.8 nm lines in the plasma observed with spectrometer III

containing 1000 µg/ml Ca, is  $\sim 1 \times 10^{-5}$  of the measured peak intensity of the Ca II 396.85 nm line. This background shift is not due to stray light or instrumental broadening, since the  $10^{-5}$  ratio is much larger than the stray light rejection ratio of  $<10^{-10}$  at 0.5 nm from the parent line specified by the manufacturer or the experimentally measured (see Figure 22 and related discussion below) ratio of  $<2 \times 10^{-7}$  at 0.4 nm. Thus, the background shift shown in Figure 21 is due to line broadening occurring in the plasma.

An extended wavelength profile for the region of the Ca II 393.37 and 396.85 nm lines, which was constructed from the net signals observed for a solution containing 1000 µg/ml Ca at discrete wavelength positions (chosen to exclude various spectral features such as weak Ca lines), is shown in Figure 22. The instrument profile, obtained with the Ne 632.8 nm line from a He-Ne laser, is also shown in Figure 22. As stated above, since the instrument profile is narrower than the Ca line profiles at intensity levels  $\sim 10^{-3}$  of the peak intensitics, the intensities in the wings of the Ca lines do not represent an instrumental artifact but line broadening in the plasma. (This conclusion is based on the assumption that the instrument profile is not strongly wavelength dependent.) The data in Figure 22 demonstrate that the wings of very strong emission lines may produce significant spectral interferences as far as 10 nm



Figure 22. Extended profile of the Ca II 393.4 and 396.8 nm lines

or more from the line center. For example, the net signal for the 1000 µg/ml Ca solution at the lowest wavelength shown in Figure 22, 384.1 nm, is  $\sim 30\%$  of the signal observed with the introduction of deionized H<sub>2</sub>O, although this net signal is only 10<sup>-6</sup> of the net signal at the Ca II 393.37 nm line center. This fraction would be somewhat less than 10<sup>-6</sup> if corrections were applied for the self-absorption occurring in the central portion of the Ca II 393.37 nm line.

The results presented in Figures 21 and 22 indicate that proper consideration must be given to spectral interferences arising from the wings of very strong lines (in addition to stray light) in the selection of analysis lines for certain matrices. Thus, another Al line such as the Al I 308.22 nm line should be employed for the determination of trace levels of Al in the presence of variable concentrations of Ca, unless suitable wavelength scanning or other empirical correction procedures are employed. Only a small loss in detection power, from 0.006 to 0.02  $\mu$ g/ml, would be involved in this alternate line choice.

Replacement of the grating in spectrometer II-A with a holographically recorded grating (designated II-B) resulted in a decrease of the background shift underlying the Al I 396.15 nm line by a factor of only  $\sim$ 5. To determine if a significant portion of this shift arose from stray light or instrumental broadening, the effect of varying Ca concentrations on the observed shifts was investigated. This

approach was necessary because a direct comparison with results obtained with spectrometer III was not possible due to differences in the instrumental bandpasses, in portions of the plasma from which the emission is sampled, and in plasma operating conditions, etc. The analytical curve obtained from the central portion of the Ca II 396.85 nm line exhibits unity slope up to a concentration of ~100 µg/ml as shown in Figure 23. Above this concentration, significant curvature toward the concentration axis is observed, which indicates the presence of self-absorption. The log-log plot of the equivalent Al concentration versus the Ca concentration obtained with spectrometer III shown in Figure 23, displays unity slope up to 10,000 µg/ml Ca. This curve is essentially an analytical curve for Ca obtained from the wing of the Ca II 396.85 nm line. These experimental results are in agreement with several theoretical treatments (133-135) which have shown that self-absorption by atoms possessing an absorption line profile identical to or narrower than the emission line profile yields a greater relative decrease in the central portion of the emission line profile than in the The plot of the Ca concentration versus the equivalent wings. Al concentrations obtained with spectrometer II-B shown in Figure 23 displays unity slope up to ~100 µg/ml, above which significant curvature toward the concentration axis is shown. Since similar curvature is observed in the central portion of

# Figure 23. Background shifts at 396.2 nm expressed in terms of equivalent Al concentration and analytical curve for the Ca II 396.8 nm line

- X Spectrometer III, 396.8 nm
- O Spectrometer III, 396.2 nm
- Spectrometer II-B, 396.2 nm



the Ca II 396.85 nm line but not in the wing (as measured with spectrometer III), a significant portion of these background shifts observed with spectrometer II-B must be due to stray light from or instrumental broadening of the central portion of the emission line.

## Far scatter

The scans in Figure 24 illustrate the effects of increasing concentrations of Ca on the observed background in the region of the Zn I 213.86 nm line with spectrometers I-A and I-C. The structure observed when deionized water was nebulized arose from  $NO_{\gamma}$  bands. Even though the Zn 213.86 nm line is coincident with one of these band components, this line is still useful for quantitative determination at concentrations less than 0.1 µg/ml Zn. With increasing Ca concentrations, upward shifts in the baseline background were observed with each of the spectrometers, but to a much greater extent for spectrometer I-A. That these upward shifts were due to stray light is clearly evident for the scans with 1000 µg/ml Ca with a borosilicate glass filter (transmittance <10<sup>-4</sup> at 213.9 nm) in the optical path (C and C' in Figure 24).

For spectrometer I-A the relatively large stray light contribution from the Ca concomitant has structure as well. Considerable far scatter structure was also observed with spectrometer I-A with a He-Ne laser when an auxiliary lens was employed to fill the full aperture of the grating.


\* WITH PYREX FILTER

Figure 24. Effect of far scatter from Ca emission on the observed background signal in the region of the Zn I 213.9 nm line

The far scatter observed with spectrometer I-A at a wavelength setting in the region of the Zn I 213.86 nm line was on the crder of 2 x  $10^{-6}$  of the sum of the measured first order peak intensities of the Ca II 393.37 and 396.85 nm lines. The 2 x  $10^{-6}$  fraction level is in harmony with other observations on some of the early gratings ruled under interferometric control (111) and is unacceptably high. It is also interesting to note that  $\sim 5\%$  of the H<sub>2</sub>O background signal (A in Figure 24) observed with spectrometer I-A was due to stray light from radiation passed by the borosilicate glass filter, whereas introduction of solutions containing 1000 µg/ml Ca produced an approximate two-fold increase in the measured background.

A reduction of stray light by a factor of ~10 relative to the Zn I line resulted when the grating in spectrometer I-A was replaced with a holographically recorded grating (designated I-C) as shown in Figure 24. Even with this reduction the background shift observed for solutions containing 1000  $\mu$ g/ml Ca (recording C' corrected for the transmittance of the filter) was still equivalent to 0.02  $\mu$ g/ml Zn, which is an order of magnitude greater than the detection limit for Zn. When the stray light generated by the Ca concomitant was expressed in terms of equivalent Zn concentration (to take into account the differences in efficiencies of the gratings), spectrometer I-B gave essentially the same performance as spectrometer I-C.

Although the major portion of the stray light shown in Figure 24 for spectrometer I-A was due to far scatter from the grating, other sources of stray light may produce significant contributions with the superior gratings in spectrometers I-B and I-C. To eliminate the contributions to the total stray light signal from the far scatter from the grating and the scattering from the exit portion of the mirror, a black velvet cloth was placed over the exit portion of the mirror. With the covered exit mirror, only ~0.1% of the baseline background signal (recording A' of Figure 24) was observed. Thus, 0.1% represents the upper limit for scattering of reflection from the black velvet. When 1000 µg/ml Ca solutions were nebulized with the exit mirror covered, approximately 10% and 25% respectively of the total stray light signals, i.e., difference between recordings B' and A' in Figure 24, for spectrometer I-B and -C were observed. Thus, 90% and 75% of the stray light signals observed with these spectrometers for 1000  $\mu$ g/ml Ca solutions were presumably due to a combination of far scatter from the grating and scattering from the exit mirror.

The recordings obtained with spectrometer II (shown in Figure 25) are very similar to those recorded for spectrometer I-C. The ICP employed with spectrometer II was operated under slightly different operating conditions than the ICP employed with spectrometer I-A, -B, and -C so that precise comparison



Figure 25. Effect of far scatter from Ca emission on the background signal observed with Spectrometer II-A in the region of the Zn I 213.9 nm line

of the performance of the spectrometers used to obtain the data in Figure 24 is not possible.

The stray light in spectrometer I-A, which was  $\sqrt{2} \times 10^{-6}$  of the sum of the peak intensities of the Ca II 393.37 and 396.85 nm lines, produced a net signal equivalent to  $\sqrt{0.2} \text{ µg/ml}$  Zn. Thus, a reduction to  $\stackrel{<}{2} \times 10^{-8}$  would be necessary to reduce the stray light from solutions containing 1000 µg/ml Ca to a net signal level less than that obtained with a solution containing Zn at the detection limit concentration (0.002 µg/ml). This level of rejection of far stray light is apparently attainable with some spectrometers presently available. However, such factors as grating efficiency, operating conditions of the ICP or other excitation source, and sample composition also play a role in determining the level of stray light rejection necessary for the reduction of stray light to a negligible level.

Knowledge of the specific radiations responsible for the stray light is a necessary prerequisite for the judicious selection of measures to eliminate the problems. To determine the origin of the stray light arising from calcium, several filters with known transmittances were placed in the optical path and the differences between the signals for solutions containing Ca and deionized  $H_2O$  (hereafter called the net signal) were measured. The results of these experiments are shown in Table VI. The principal origin of the

Spectrometer	Sample nebulized	Normalized signal at a wavelength setting of 213.93 nm	Net signal <sup>a</sup>	Net signal <sup>a</sup> with boro- silicate glass filter	Net signal <sup>a</sup> with CS-3-75 filter	Net signal <sup>a</sup> with CS-3-72 filter
I-A or I-C	н <sub>2</sub> о	100				
I-A	- 1000 μg/ml Ca	193	93	80(91) <sup>b</sup>	25(89) <sup>C</sup>	$\sim$ 0.1 <sup>d</sup>
I-C	1000 µg∕ml Ca	108	8	7(8)	2(7)	<b>∿</b> 0
I-A	10,000 µg/ml Ca	388	288	227(258)	69(246)	∿1.3
I-C	10,000 µg/ml Ca	129	29	15(17)		

Table VI. Effect of filters on the stray light from Ca

<sup>a</sup>Net signal = sample signal - signal for  $H_2O$  (with filter for 5th, 6th, and 7th columns).

<sup>b</sup>Values in parentheses are corrected for the transmittance of the borosilicate glass filter at 393.37 nm, i.e., Net ÷ transmittance of borosilicate glass filter.

<sup>C</sup>Values in parentheses are corrected for the transmittance of CS=3=75 filter at 393.37 nm (0.26) and 396.85 nm (0.31), weighted for the relative intensities of the Ca II 393.37 and 396.85 nm lines, i.e., Net  $\div$ 0.26.

 $^{\rm d}{\rm Transmittance}$  of CS-3-72 filter was <10 $^{-4}$  at 393.37 nm and  ${\sim}0.8$  from 490 to >750 nm.

stray light may be assigned with confidence if quantitative agreement is found between the net signal with no filter (column 4 of Table VI) and the net signals with several carefully chosen filters, after corrections for the transmittance of the filters at the suspected wavelength of the stray light (values in parentheses in columns 5 and 6 of Table VI). As shown in the fifth column of Table VI, the net signals observed for the 1000  $\mu$ g/ml Ca solution were only slightly attenuated by a borosilicate glass filter (transmittance of  $<10^{-4}$  at 213.86 nm). After correction for the transmittance of the borosilicate glass filter at 393.37 nm (or, because of the plateau in the transmittance curve of the filter, any wavelength between  $\sqrt{350}$  nm and >750 nm), reasonable quantitative agreement was obtained with the net signals observed for the 1000  $\mu$ g/ml Ca solution with no filter (column 4). Thus, the majority of the net signals for the 1000  $\mu$ g/ml Ca solution were due to radiation passed by the borosilicate glass filter. The net signals for the 1000 µg/ml Ca solution were partially attenuated with the CS-3-75 filter (Corning Glass Works) as shown in the sixth column of Table VI. This filter is a sharp-cut filter with transmittances of <0.1 for wavelengths below 375 nm, 0.26 at 393.37 nm, 0.31 at 396.85 nm, and >0.8 at wavelengths above 460 nm. After correction for the measured transmittances of the filter at the Ca II 393.37 and 396.85 nm lines,

weighted for the relative intensities of these lines, reasonable quantitative agreement was found with the net signals observed with no filter. For the CS-3-72 filter, which is a sharp-cut, high wavelength pass filter with a transmittance of  $<10^{-4}$  at 396.85 nm, the net signals for the 1000 µg/ml Ca solution were nearly completely attenuated. This filter rejects the intense Ca lines at 393.37 and 396.85 nm but passes the radiation from the CaO and CaOH bands in the visible. The data in column 7 show that only a negligible net signal is observed, hence the major portion of the stray light observed with the 1000 µg/ml Ca solutions at a wavelength setting adjacent to the Zn I 213.86 nm line with spectrometers I-A and I-C arose from the Ca II 393.37 and 396.85 nm lines.

It is evident from the data in column 4 of Table VI that the net signals for 10,000  $\mu$ g/ml Ca solutions were not increased 10-fold over those observed for the 1000  $\mu$ g/ml solutions. Changes in the nebulization and transport efficiencies, self-absorption of the Ca II lines, or shifts in the real spectral background may have introduced a downward bias in the expected increase in the net signal. On the other hand, for spectrometer I-C, only half of the net signal was observed for the 10,000  $\mu$ g/ml Ca solution when the borosilicate glass filter was inserted into the optical path. Thus, for concentrations of Ca greater than 1000 $\mu$ g/ml, either the stray light from other Ca lines became

more significant, or the real spectral background was affected by the introduction of solutions containing >1000  $\mu$ g/ml Ca.

The effects of increasing concentrations of Mg in the nebulized solution on the background observed near the Zn I 213.86 nm line are shown in Figure 26. As in the case of Ca, the upward shifts in the background observed with increasing concentrations of Mg with these spectrometers, as well as the apparent change in structure for spectrometer I-A, were due to stray light as shown by the tracings with the CS-9-54 filter (Corning Glass Works) in the optical path. This filter is a sharp-cut, high-pass filter with transmittances of 0.05 at 213.86 nm and 0.86 at 280 nm. Thus, the CS-9-54 filter transmits most of the radiation from the very intense Mg II 279.55 and 280.27 nm lines. which are the principal sources of the stray light arising from appreciable concentrations of Mg in the ICP. When the stray light at 213.86 nm was expressed in terms of equivalent µg/ml Zn (to account for the differences in efficiencies of the gratings), the performance of spectrometer I-B was essentially the same as spectrometer I-C. Only  $\gtrsim 2\%$  of the total stray light was observed in spectrometers I-B and I-C at 213.9 nm when the exit portion of the mirror was covered with black velvet. Thus,  $\sqrt{98\%}$  of the stray light (difference between B' and A' in Figure 26) appeared to arise from



Figure 26. Effect of far scatter from Mg emission on the observed background signal in the region of the Zn I 213.9 nm line

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grating scatter or from scattering from the exit portion of the mirror of the first order Mg II 279.55 and 280.27 nm lines (with possibly some contributions from the Mg I 285.2 line).

For spectrometer I-A the stray light level at a wavelength setting adjacent to the Zn I 213.86 nm line was  $v4 \ge 10^{-6}$  of the measured peak intensities (first order) of the Mg II 279.55 and 280.27 nm lines. Because the stray light observed when solutions containing 1000 µg/ml Mg were nebulized into the plasma produced a net signal equivalent to  $v0.12 \ \mu$ g/ml Zn, a reduction to  $<7 \ge 10^{-8}$  would be necessary at this Mg concentration to produce a net signal less than that obtained with a solution containing Zn at the detection limit concentration (0.002 µg/ml). This level of rejection of far stray is apparently attainable with some spectrometers presently available.

To eliminate the stray light contributions to the background signal adjacent to the Zn I 213.86 nm line, a uv interference filter (transmittances of 0.34 at 213.86 nm,  $\sim 0.004$  at 279.6 nm, and 0.0002 at 393.4 nm; 78-2, Acton Research Corp., Acton, MA) was inserted in the optical path preceding the entrance slit of spectrometer II-B. No significant differences in the signals were observed for deionized H<sub>2</sub>O and 1000 µg/ml Ca or Mg solutions with a CS-9-54 filter in the optical path (in addition to the

interference filter). Thus, the interference filter reduced the stray light from longer wavelength Ca or Mg radiation to insignificant levels. The absence of stray light from radiation occurring within or below the bandpass of the filter was not unequivocally established. As shown by the normalized intensities in Table VII the addition of up to 1000 µg/ml Ca or Mg to the nebulized solution produced no significant change in the measured background signal, i.e.,  $\approx$ 1% of the background signal. The data in Table VI also indicate that the addition of up to 1000 µg/ml Li, 6900 µg/ml Na, or 20,000 µg/ml K produced no significant change in the background signal, although significant shifts were observed with the 5000 µg/ml Li and 23,000 µg/ml Na solutions. Depressions in the background signals from ICP's have been observed by Scott and Strasheim (136) for solutions containing K, Li, Mg or Ca (no corrections for the stray light were indicated) at 213.86 nm and by Dalager (137) for solutions containing Ca or Mg at several wavelength positions below 238.9 nm with interference filters immediately in front of the detectors. These discrepancies appear to be due to differences in operating conditions and require further study. For example, the data in Table VII were obtained with the capacitors of the impedance matching circuit at the positions which yielded the minimum reflected power meter reading ( $\tilde{<}5$  W) with the introduction of deionized

Sample	nebuli	.zed	Normali a wavel of 213.	zed signal of ength setting 93 nm		
Н <sub>2</sub> О			100			
200	∠ µg/ml	Ca	100.2 ±	1.4 <sup>a</sup>		
500	µg/ml	Ca	99.6 ±	0.9		
1000	µg/ml	Ca	99.6 ±	1.0		
200	µg/ml	Mg	100.l ±	0.8		
500	µg/ml	Mg	100.0 ±	1.2		
1000	µg/ml	Mg	100.9 ±	1.2		
1000	µg/ml	Li	100.3 ±	0.9		
5000	µg/ml	Li	106.1 ±	1.0		
2300	µg/ml	Na	99.7 ±	0.8		
6900	µg/ml	Na	99.4 ±	1.1		
23,000	µg/ml	Na	97.1 ±	1.2		
100	µg/ml	К	100.1 ±	1.3		
1000	µg/ml	K	99.5 ±	1.3		
20,000	µg/ml	K	100.4 ±	1.2		

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Table VII. Effects of various elements on observed background signal with interference filter

<sup>a</sup>Limits are the standard deviation.

 $H_00$ . If the capacitors were readjusted to yield a reflected power of 15 W, depressions up to 14% of the background signals were observed which were accompanied by increases in the reflected power in apparent agreement with the observations of Scott and Strasheim (136). However, upward shifts in the spectral background adjacent to the Zn I 213.86 nm line were observed with spectrometer III with the introduction of solutions containing 200 to 1000  $\mu$ g/ml Mg (but not Ca). For example, the shift observed with the 1000  $\mu$ g/ml Mg solution was  $\sqrt{7\%}$  of the signal observed without These shifts could not be attributed to stray light. Mg. Preliminary experiments have shown that various experimental parameters influence the relative magnitude of the shifts in the true spectral background, e.g., the radiofrequency power level, plasma gas flow rate, and the region from which the emission is sampled. Hence, the discrepancy between the above mentioned results from spectrometer III and the data in Table VII may be attributed to differences in the excitation sources. However, definitive investigations of the effects of various elements on the true spectral background will require high stray light rejection.

It is interesting to note that even without an interference filter, the stray light passed by a borosilicate glass filter with spectrometer I-A amounted to less than 1% of the background signal observed without the filter at

213.93 nm when solutions containing 5000 µg/ml Li, 23,000 µg/ml Na, or 20,000 µg/ml K were nebulized. The relatively low stray light level may be attributed to several factors. First, the high degree of ionization of the alkali elements in the ICP leads to rare gas configurations, whose sensitive lines occur in the vacuum ultraviolet region. Second, there is a large wavelength separation between the most sensitive atomic lines of these elements and the 213.93 nm wavelength setting. Finally, S-13 photocathodes have low quantum efficiency at the wavelengths of the sensitive atomic lines of these of these elements and the sensitive atomic lines of these of the sensitive atomic lines of these elements.

## Extraneous sources of stray light

Although grating imperfections have been identified above as the primary source of stray light in some grating spectrometers, improvements in the stray light characteristics of gratings have increased the relative importance of other extraneous sources of stray light. For example, reflections and scattering of the Ca II 393.37 nm line in the exit slit assembly of spectrometer I-A caused significant levels of stray light as shown by the broad line (marked A) in Figure 19.

As noted above, dispersed radiation that passes through the appropriate exit slits of polychromators may undergo scattering and reflection from the secondary mirrors employed to deflect the radiation to the appropriate detector from

secondary mirror posts, and from other surfaces beyond the exit slit. To assess the magnitude of the stray light that eventually reaches the detectors from these sources, all of the exit slits in spectrometer II, except those of Ca II 393.37 and Mg II 279.55 nm lines were blocked. Although all exit slits other than those of Ca and Mg were blocked, it is still possible to scan each of the other 45 spectral lines across their appropriate blocked exit slits. This scanning action is achieved by moving the entrance slit along the Rowland circle to change the angle of incidence of the source radiation on the grating. During this experiment no signal should, of course, be observed in the blocked channels if stray light does not originate in the secondary optics. The recordings in Figures 27 and 28 definitely show that is not so. When solutions containing Ca and Mg were nebulized, it is seen that "pseudo lines" were recorded for the Tl I 377.57 and Fe 261.19 nm lines, at precisely the wavelength scanning position (slit dial position = -9.20corresponding to the passage of the Ca II and Mg II lines through their respective exit slits. Similar scans were obtained for other programmed channels. Because the solutions contained no detectable Tl or Fe and the exit slits for these channels were blocked, these signals did not originate from characteristic Tl or Fe radiation passing through the exit slits. These signals, in fact, resulted from scattering and



Figure 27. Stray light originating in the secondary optics of spectrometer II-A measured on the Tl II 377.57 nm channel



Figure 28. Stray light originating in the secondary optics of spectrometer II measured on the Fe II 261.19 nm channel

reflections of the Ca and Mg ion line radiation in the secondary optics region during the transit of these lines across their respective exit slits.

In spectrometer II other extraneous sources of stray light were present in addition to that generated by scattering and reflection in the secondary optics of radiation passing through the exit slits. For example, the difference in the measured signals for the scans with deionized  $H_0O$  and the 1000 µg/ml Mg solutions in Figure 27 was essentially the same as that observed in another experiment with all of the exit slits blocked. Similarly, the signals observed for the 1000 µg/ml Ca solution with all exit slits blocked except for the Ca II and Mg II lines (Figure 27) at scan positions sufficiently removed from the -9.20 slit dial position, e.g., at -9.40, did not differ significantly from those observed with all of the exit slits blocked. A portion of these stray light signals apparently arose from radiation reflected from the bright metallic finish on the face of the exit slit jaws which escaped through the tubing and baffling leading to the entrance slit.

The stray light signals observed in spectrometer II for the 1000  $\mu$ g/ml Ca or Mg solutions with all of the exit slits blocked except for the Ca II and Mg II lines ranged from an insignificant fraction of the total stray light signal with all slits opened to as much as a half of this total. However,

with improvements in the stray light characteristics of gratings, these other sources of stray light may become more significant, thus requiring higher quality engineering in the design and construction of polychromators.

The data presented above strongly suggest that the upward shifts in the measured background produced by relatively high concentrations of Ca reported previously by Borms <u>et al</u>. (138), Scott and Kokot (76), and Boumans and de Boer (139) were due to stray light rather than actual shifts in the true spectral background. The stray light effects documented above have undoubtedly occurred in other optical emission studies but have not been recognized because analyses were not performed near detection limit concentrations, or the effects of stray light were obscured by indirect effects on the real spectral background, or other interelement interactions caused far greater excursions in net line intensities.

It should be realized that upward shifts in the measured background may be produced not only by stray light arising from a few very intense lines but also by a large number of less intense lines or molecular bands. For instance, the introduction of solutions containing 1000  $\mu$ g/ml of Fe, Mn, or Al produced a shift in the background (above that observed with the introduction of deionized H<sub>2</sub>O only) adjacent to the Zn I 213.86 nm line equivalent to  $\sim 0.2$ ,  $\sim 0.14$ , or  $\sim 0.06 \mu$ g/ml Zn, respectively with spectrometer I-A. Since there are

large variations in the stray light characteristics of different spectrometers and even in gratings produced by the same technique, it is important to identify these effects with each spectrometer.

Solutions to the Stray Light Problem

Stray light levels may be decreased significantly through the use of "state of the art" gratings and optical components as well as through quality engineering in the design of spectrometers. For example, all nonoptic surfaces within a spectrometer should possess an optically flat black coating. Baffles should be located to trap the zero and other order radiations that are not used. In polychromators light tunnels and baffles may be necessary at appropriate locations in the secondary optics region to prevent optical "cross-talk" between channels. Stray light in the secondary optics region may also be reduced by elimination or temporary blockage of exit slits for intense lines of elements normally present in samples at varying high concentrations. However, reduction of stray light to insignificant levels for all sample types may not be possible even with "state of the art" single-pass spectrometers.

Normal interference correction procedures can be used to correct for stray light once the concomitants causing the stray light have been identified. Preliminary results (77) have revealed that empirical correction coefficients based

on a linear relationship with the interferent concentration do not generally provide valid corrections. These results imply that either correction curves should be established or the coefficients should be based on measured intensities of the parent line or lines. Direct reading polychromators simplify this task by allowing simultaneous measurement of the parent concomitant intensities from which appropriate correction coefficients may be calculated. Stray light arising from the cumulative effect of many elements or lines may, however, necessarily complicate the correction procedure.

Double monochromatization (129) provides a substantial reduction of stray light (the ratio of the stray light intensity to the parent line is squared) and should eliminate the need for corrections for stray light in nearly all situations. Prism predispersion will also provide significant reduction of stray light in many situations.

The judicious selection of the spectral response of the detectors may be used to good advantage in reducing stray light contributions. For example, solar blind photomultipliers employing Cs-Te or Rb-Te photocathodes may substantially reduce or eliminate the long wavelength stray light contributions from Ca in the determination of Zn or other elements with sensitive lines below ~300 nm. However, no reduction can be expected for the stray light contribution

from Mg. Optical filters can also provide an effective means of stray light reduction. In many cases sufficient rejection of far stray light may be achieved with narrow bandpass interference filters placed immediately in front of the detectors in a polychromator (140,141) or in front of the entrance slit of a monochromator. As discussed in a previous section, the stray light at a wavelength setting of 213.93 nm arising from a solution containing 1000  $\mu$ g/ml Ca or Mg was essentially eliminated with an interference filter in the optical path. Interference filters for the 190-230 nm region, which were placed immediately in front of the detectors in spectrometer II-B, eliminated the stray light from up to 1000  $\mu$ g/ml Ca (140). Upward shifts in the true spectral background were also observed with solutions containing Mg in agreement with the observations with spectrometer III with the same ICP facility discussed above.

Wavelength scanning or modulation techniques (142-145) provide excellent background correction for constant or slowly varying background and should provide correction for baseline shifts in the background produced by stray light. It should be realized that stray light often possesses significant structure, <u>e.g.</u>, Rowland ghosts as illustrated by the tracings in Figure 20, the far scatter with spectrometer I-A in Figures 24 and 26, and the "pseudo lines" originating from scattering and reflection in the secondary

optics region illustrated in Figures 27 and 28. It should be recognized that wavelength scanning or modulation techniques can compensate for shifts in the true spectral background which may result from the wings of spectral lines as illustrated in Figures 21 and 22, or from other sources such as those discussed in the Introduction of this chapter. Further research is needed to determine which approach in this broad category provides the most valid background correction. Careful consideration should be given to situations in which the background or background shift possesses structure or in which a spectral line occurs near the analysis line.

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